







Vacancy dynamics in niobium and its native oxides and their potential implications for quantum computing and superconducting accelerators

Marc Wenskat ^{1,*}, Jakub Čížek,² Maciej Oskar Liedke,³ Maik Butterling,³ Martin Stiehl,⁴ Guilherme Dalla Lana Semione ^{1,5,6}, Constanze Backes,⁴ Christopher Bate ^{1,5}, Oksana Melikhova,² Eric Hirschmann ³, Andreas Wagner,³ Hans Weise ⁵, Andreas Stierle,⁵ Martin Aeschlimann,⁴ and Wolfgang Hillert ¹

¹*Institute of Experimental Physics, University of Hamburg, 22607 Hamburg, Germany*

²*Faculty of Mathematics and Physics, Charles University, 12116 Prague, Czech Republic*

³*Institute of Radiation Physics, Helmholtz-Zentrum Dresden-Rossendorf, 01328 Dresden, Germany*

⁴*Department of Physics, Technical University of Kaiserslautern, 67653 Kaiserslautern, Germany*

⁵*Deutsches Elektronen-Synchrotron DESY, 22607 Hamburg, Germany*

⁶*MAPEX Center for Materials and Processes, University of Bremen, 28334 Bremen, Germany*



(Received 7 March 2022; revised 20 July 2022; accepted 26 August 2022; published 27 September 2022)

In recent years, superconducting radio-frequency (SRF) cavities have been considered as candidates for qubits in quantum computing, showing longer photon lifetimes and, therefore, longer decoherence times of a cavity stored qubit compared to many other realizations. In modern particle accelerators, SRF cavities are the workhorse. Continuous research and development efforts are being undertaken to improve their properties, i.e., to increase the accelerating field and lower the surface resistance, which in turn increase the energy reach and duty cycle of accelerators. While some experimental milestones have been achieved, the mechanisms behind the still observed losses remain not fully understood. In this contribution we are going to show that a recently reported temperature treatment of Nb SRF cavities in the temperature range of 573–673 K, which reduces the residual surface resistance to unprecedented values, is linked to a reorganization of the niobium oxide and near-surface vacancy structure and that this reorganization can explain the observed improved performance in both applications, quantum computing and SRF cavities.

DOI: [10.1103/PhysRevB.106.094516](https://doi.org/10.1103/PhysRevB.106.094516)

I. INTRODUCTION

Electrical properties of oxides are significantly affected by vacancylike defects. For instance, it is known that oxygen vacancies can lead to an n -type doping, which causes surface magnetism of otherwise dielectric material [1–3]. Such local *magnetic impurities* have already caught the attention of the superconducting radio-frequency (SRF) community. They can cause subgap states, which alter the performance of SRF cavities by contributing to dissipation mechanisms [4–9].

Whenever superconducting quantum interference devices (SQUIDs) were used as qubits or, in modern architecture of qubits, the so-called transmon, the oxide layer acts as weak link and contains many defects. These defects are described as lossy two-level systems (TLS), which severely limit the coherence time to just a few nanoseconds, [10–15]. To increase the coherence time is the major goal in developing technical realizations of qubits, hence a better understanding of microscopic realizations of TLS is mandatory. And in fact

oxygen vacancies have been suggested as ideal candidates for TLS [16–18]. For example, in [17], the surface vacancy states of Al_2O_3 and SiO_2 were studied using density functional theory (DFT), resulting in dangling bond states on the surface assembling localized magnetic moments. Such dangling bonds are exemplary realizations for a TLS in an amorphous material, and can increase the noise level [19]. Another example is hydrogen-vacancy complexes which can act as TLS, as they form the so-called threefold degenerate rotors with tunnel splittings in the MHz to GHz range [16]. In particular, hydrogen-vacancy complexes in niobium have been proved to exist and are considered to have detrimental impact onto the RF performance. All those different realizations of TLS can provide a microscopic explanation of the observations in the recent application of SRF cavities for quantum computing [20,21], in which photon lifetimes of 2 s were observed, after the niobium surface underwent a dedicated annealing procedure.

This procedure, namely an annealing treatment at 573–673 K *in situ* for 3 h in UHV (the newly dubbed mid-T bake”), showed extremely high quality factors of $Q_0 \approx 5 \times 10^{10}$ with a residual resistance below 1 n Ω at 2 K [22]. In addition, a behavior called “anti- Q -slope,” which is a positive slope of Q_0 as a function of the accelerating field E_{acc} , was observed. This implies a reduction of the resistance, as described by the BCS theory, with increasing accelerating field. Such behavior has been observed for 1.3 GHz only in the case of so-called

*marc.wenskat@desy.de

doped cavities so far [23,24] and is not well understood yet, although theoretical treatments do predict this counterintuitive phenomenon [25,26]. There are reports of anti- Q -slope behavior on 3.9 GHz cavities [24] and 3 GHz cavities [27], both without doping. This frequency dependence might help to identify the microscopic origin of this behavior [9,28–30]. As has been reported by He *et al.* and Ito *et al.* [31,32], the mid-T bake was successfully reproduced at other laboratories rather fast. Moreover, the requirements on the process parameters have been further relaxed, i.e., using standard furnaces and simplified handling with niobium caps installed on cavities, rather than *in situ* annealing of whole cavities and their transport while still under vacuum to the cryogenic RF testing area, as done by Posen *et al.* [22].

The aim of this work is twofold: (i) to study vacancies in the native niobium oxide, as potential cause for the reduced coherence time but also as cause for subgap states, increasing the surface resistance of cavities; (ii) to study vacancy complexes within the niobium, which influence the interstitial oxygen and hydrogen concentration and therefore play an important role in the formation of *nanohydrides*, also increasing the surface resistance of cavities.

In order to investigate the vacancy dynamics, we utilized positron spectroscopy. As positrons can easily get trapped in metal vacancy defects and are known to be very sensitive to their elemental environment, they are the optimal choice to analyze the types, concentrations, and atomic environment of empty crystal sites [33]. Hence, we looked with *in situ* and *ex situ* experiments at the dynamics. To analyze and interpret the obtained data, we used *ab initio* calculations. Complementary to these methods, we applied x-ray reflectivity (XRR), which is a widely employed technique to study thin films and multilayered materials, to observe the niobium-oxide development and dissolution during the annealing procedures. This was crucial for the further discussion, as those layers act as the primary source for interstitial diffusion of oxygen and have a significant influence on the material structure in the near-surface region. Guided by our results and theoretical models, we started to study the magnetic order of the oxide. For this we identified Kerr microscopy as the most versatile method and proved the existence of magnetic domains in the niobium oxide.

In this work we report on the vacancy dynamics and their interactions with oxygen and hydrogen as interstitials in niobium, by applying various annealing temperatures, as well as the kinematics in the native oxide layer. Furthermore, we show how the same microscopic states (oxygen defects and interstitial trapping at vacancies) can explain the observations in SRF cavities for different applications, namely quantum computing and accelerators.

II. METHODS

A. X-ray reflectivity

In the frame of this work Nb(100) specimens were studied after stepwise sequential annealing under UHV vacuum conditions. Each step was followed by *in situ* XRR measurements using a photon energy of 70 keV. Data were collected using a Maxipic 2D, used for sample alignment and to perform XRR measurements [34]. A formalism developed in [35] takes

effects of multiple scattering events and interfaces into account. The XRR curves were fitted using the Parrat formalism with FEWLLAY, taking into account finite resolution effects [36]. For each layer j of the fit model a set of four parameters was attributed by the fitting routine: layer thickness d_j , layer roughness σ_j , and the optical quantities δ_j and β_j , which compose the index of refraction n_j of the probed layer [34].

B. Positron annihilation spectroscopy

In principle, two approaches can be utilized: (i) positron annihilation lifetime spectroscopy (PALS), where positron lifetime in a material is measured, and (ii) Doppler broadening (DB) of the annihilation photo-peak, which is realized as a measurement of the Doppler shift of annihilation radiation [37]. The positron lifetime is governed by the local electron density at the positron annihilation site; i.e., PALS provides information about the type and concentration of open volume defects in a material [38]. The Doppler shift of the annihilation radiation is determined by the momentum of the electron which annihilated the positron. In DB positron annihilation spectroscopy (PAS), the broadening of the annihilation photopeak is characterized in terms of the lineshape parameters S (sharpness) and W (wing), which contain information about the contributions of annihilation by low or high momentum electrons, respectively. Hence, the correlated measurement of S and W parameters is also sensitive to the type and the atomic environment of positron trapping sites or defects. More details on the method is given in Appendix B.

Depth resolved variable energy positron annihilation spectroscopy (VEPAS) studies of the subsurface region were carried out at the Helmholtz-Zentrum Dresden-Rossendorf facility on a continuous slow positron beam “SPONSOR” [39] with an apparatus for *in situ* defect studies “AIDA” [40] employing DB-VEPAS, as well as on a pulsed positron beam “MePS” [41] at the ELBE facility employing positron lifetime (VEPALS). The spot size diameter of the positron beams was in the order of 5–6 mm and the energy of incident positrons was adjusted to the range 0.05–36 keV for DB-VEPAS (it corresponds to the mean positron penetration depth into Nb from 0.02 to 1380 nm) and 1–10 keV for VEPALS (it corresponds to the mean positron penetration depth into Nb from 4.7 to 394 nm). Both DB-VEPAS and VEPALS measurements were done *in situ*, i.e., samples were baked in the sample chamber with simultaneous irradiation by the slow positron beam. The data obtained at MePS were analyzed using the PALSFIT3 software [42] and the plots were generated using ORIGINLAB [43].

C. Kerr microscopy

This microscopical approach utilizes the magneto-optical Kerr effect to visualize and characterize the magnetic behavior of materials and is a well established technique to study magnetization. The system used is an in-plane Kerr magnetometer (Zeiss Axio Imager Z2 Vario upgraded by Evico Magnetics GmbH) and a magnetic field in the range of ± 200 mT was applied. The measurements were done at room temperature (RT) with sensitivity to the first 15 nm of the surface. The in-plane orientation of the magnetic field and the applied

field values are similar to what the niobium surface experiences during accelerator operation. The small penetration depth is also beneficial due to being more sensitive to oxide layer effects, and is of a similar order of magnitude as the London penetration depth of niobium, probing the surface relevant for the SRF behavior. On each sample, an area of 672×554 pixels² or $\approx 448 \times 369$ μm^2 was scanned to obtain the magnetization curve, while multiple, smaller areas were also scanned to study the spatial homogeneity of the hysteresis and investigate regions of interest.

D. *Ab initio* calculations

Vacancies in Nb and their complexes with the most relevant gas impurities (H, O, N) were modeled using density functional theory (DFT) implemented in the Vienna *ab initio* simulation package (VASP) [44,45]. Electronic structure calculations were performed employing the projector augmented wave (PAW) method [46]. The generalized gradient approximation (GGA) with the exchange-correlation functional of Perdew, Burke, and Ernzerhof (PBE) [47] was used. The calculations were performed using supercells containing 128 atomic sites and consisting of $4 \times 4 \times 4$ bcc unit cells with the lattice parameter $a = 3.322$ Å obtained by structure optimization. The energy cutoff of the plane wave basis of 500 eV and Fermi smearing of the electronic occupancy with a width of 0.2 eV were used in all calculations. Reciprocal space was sampled using a $3 \times 3 \times 3$ k -point mesh generated applying the Monkhorst-Pack scheme [48]. Convergence tests revealed that calculated energies are converged to within ≈ 0.01 eV. Equilibrium geometries of defects were determined by fully relaxing ion positions and volume of the supercell. Structural relaxations were performed until forces on each atom were smaller than ≈ 0.01 eV/Å. Positron annihilation observables were calculated using DFT within the so-called standard scheme [49]. In this approximation, the positron density is assumed to be negligibly small everywhere and not affecting the bulk electron structure. The momentum distribution of the annihilating electron-positron pairs was calculated using the approach described in Refs. [50,51]. Further background is given in Appendix C.

E. Samples

The samples used for the positron studies and the Kerr microscopy were cut out of a niobium sheet from the European XFEL cavity production, where the sheet was produced by Tokyo Denkai Co. Ltd., and the mechanical and chemical properties of the Nb sheets supplied by the producer are summarized in Table I.

The sample geometry is of flat-conical design, with a base diameter of 12 mm, a top diameter of 10 mm, and a thickness of 2.8 mm. They were cut from the sheet by a water jet cutter and turned to their final shape. The samples used for positron spectroscopy and Kerr microscopy were prepared following closely the standard cavity preparation and the intermediate cleaning and rinsing was carried out in an ISO 4 clean-room environment [52–55]; see Appendix A for details.

The samples used for the x-ray reflectivity measurements were mechanically polished single-crystal niobium (100)

TABLE I. Material properties of the niobium sheets: Vickers hardness (HV), tensile strength (R_m), yield strength (R_p), and concentrations of vacancies (c_v), oxygen (c_O), nitrogen (c_N), hydrogen (c_H), and carbon (c_C).

| | Tokyo Denkai |
|----------------------------|--------------|
| HV | 42.5–50.6 |
| R_m (N/mm ²) | 170 |
| R_p (N/mm ²) | 62 |
| c_v (ppm at) | 8–10 |
| c_O (ppm at) | 3.5–4.5 |
| c_N (ppm at) | 3.2–4.4 |
| c_H (ppm at) | 0.5–0.8 |
| c_C (ppm at) | 0.2–0.7 |

samples of cylindrical design (10 mm diameter, 2 mm height) oriented to better than 0.1° . The samples were annealed at 2273 K for 6 h by induction heating in an ultrahigh vacuum (UHV) at a starting pressure of 10^{-10} mbar and unavoidably exposed to air for several days before the experiments. This procedure ensures that the Nb single crystals are as clean as possible in the bulk.

III. RESULTS

A. *In situ* X-ray reflectivity

With the exception of measurements at room temperature, *in situ* XRR curves were collected twice for each temperature step: first, after the sample temperature was deemed stable following an increase in the heater current (usually 1 h, here labeled t_1) and a second time after more than 12 h of annealing (labeled t_2). All collected and fitted XRR curves together with the respective electron density profiles are shown in Fig. 1.

At first, as shown in Fig. 1, the natural oxide layer presented the typical composition from the surface to the metal/oxide interface with Nb₂O₅, NbO₂, and NbO displaying layer thicknesses of 1.8, 1.3, and 0.8 nm (error bar of ± 0.1 nm) with associated roughness between 0.2 and 0.4 nm for the oxide/metal interfaces [34]. The same stack order is observed upon annealing at 393 K for both times t_1 and t_2 . Initially (time t_1), the oxides are virtually unaffected by the annealing treatment, with their respective thicknesses and roughness values remaining within the uncertainty of the fits (± 0.1 nm). Hardly affecting Nb₂O₅ and NbO, the extended annealing at 393 K (time t_2) leads to a partial consumption of NbO₂, as observed by a decrease of 0.2 nm in its layer thickness. Meanwhile, all roughness values remained in a similar range.

At 473 K a pronounced reduction of the oxide thickness was observed. After ≈ 1 h (t_1), the thickness of the outermost oxides, Nb₂O₅ and NbO₂, decreased to 0.6 and 0.3 nm, respectively. By contrast, the NbO layer thickness increased to 1.1 nm. Nevertheless, the total oxide thickness at this stage decreases to about 2 nm, which corresponds to a drop of $\approx 54\%$. Further annealing at 473 K (time t_2) only affected the roughness of the NbO/Nb interface, which rose by 0.25 nm.

The complete consumption of Nb₂O₅ was achieved at 523 K after ≈ 1 h (t_1) already. At this stage NbO₂ was also partially removed, reaching a layer thickness of 0.8 nm. As the

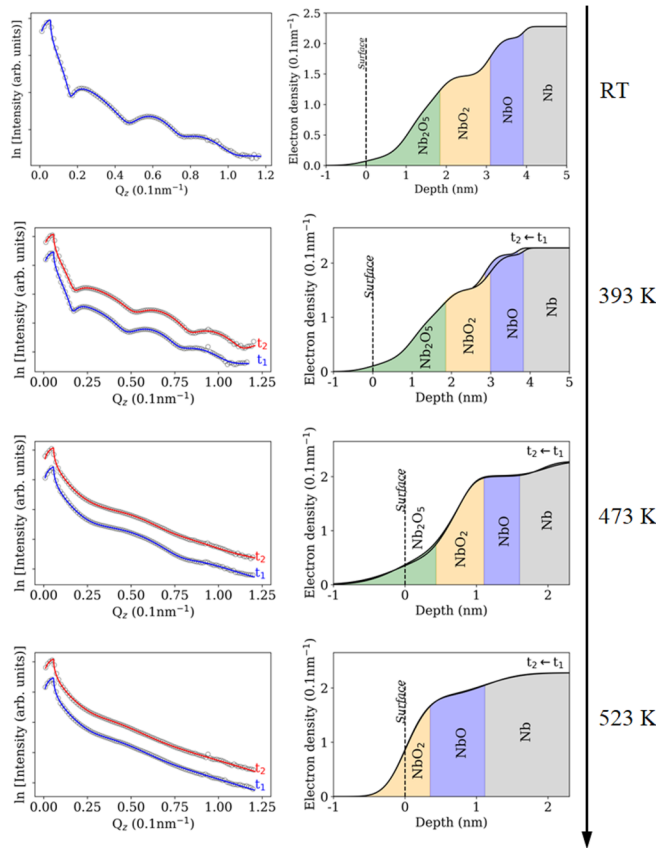


FIG. 1. Left: X-ray reflectivity data (open circles) measured with photon energies of 70 keV with the respective fits (solid lines). The scans are offset in the y direction. Right: Electron-density profiles obtained from the fits of the data. The measurement collected data from RT up to 523 K.

annealing time at 523 K is extended (time t_2), a progressive etching of NbO_2 to 0.7 nm was indicated by the analysis, although the difference between the thicknesses obtained from the curves t_1 and t_2 falls within the error bar of the fits.

B. *In situ* Doppler broadening variable energy positron annihilation spectroscopy (DB-VEPAS)

The *in situ* annealing of a Nb sample was conducted in the AIDA chamber [40] with simultaneous DB-PAS measurements at constant $E_p = 1.5$ keV. The annealing scheme is sketched in Fig. 2(a). A constant ramping rate of 1 K/min was used and each up ramp was followed by a 4 h dwell at the target temperature in the absolute range of 343–573 K and a subsequent ramping down to room temperature (RT). The data were continuously collected and accumulated as 600 s packages. The annihilation line parameters S and W , as well as the $3\gamma/2\gamma$ ratio, were calculated from the data and are presented as a function of the overall experiment time in Figs. 2(b), 2(c), and 2(d), respectively. After each ramp down to RT, a full positron implantation energy E_p (depth) scan was conducted in order to estimate defect microstructure steady states. The measured $S(E_p)$ curves are plotted in Fig. 3, while Fig. 4 shows the S - W plot for positron energy $E_p = 1.5$ keV corresponding to the mean positron penetration depth of about

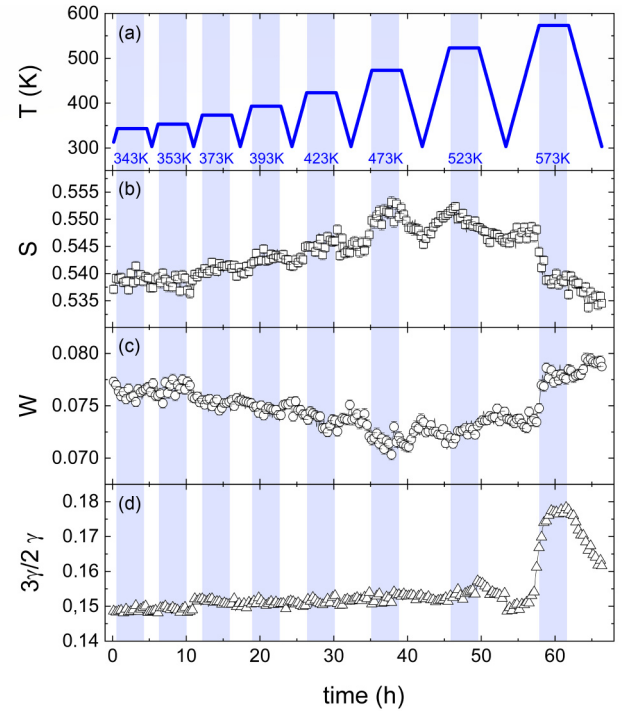


FIG. 2. *In-situ* annealing of a Nb sample in the AIDA chamber with simultaneous DB-PAS measurement at $E_p = 1.5$ keV. A sketch of temperature variations during the experiment (a), where a constant ramping of 1 K/min was used followed by a 4 h dwell at a given temperature in the range of 343–573 K and ramping down to room temperature. Each measurement point represent 600 s of data acquisition. The annihilation line parameters: low electron momentum fraction S (b), high electron momentum fraction W (c), and $3\gamma/2\gamma$ ratio (d) as a function of the experiment time. Annealing dwell times are marked by the blue regions.

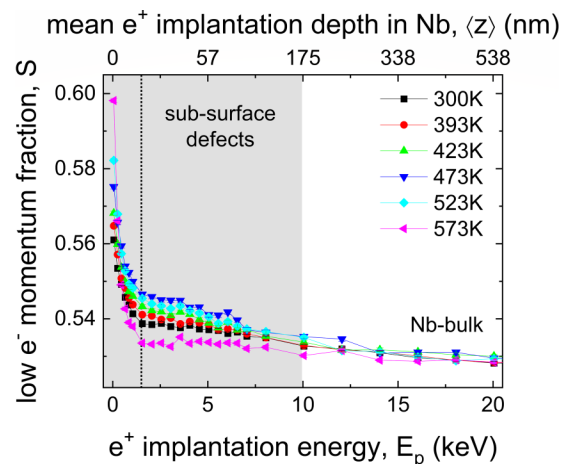


FIG. 3. Annihilation line parameter S as a function of positron implantation energy E_p and mean positron implantation depth $\langle z \rangle$ after sequential *in situ* annealing in the temperature range of $T = 300$ –573 K. The subsurface region containing defects is marked in gray. A vertical line at $E_p = 1.5$ keV denotes the depth selected for continuous DB-VEPAS measurements.

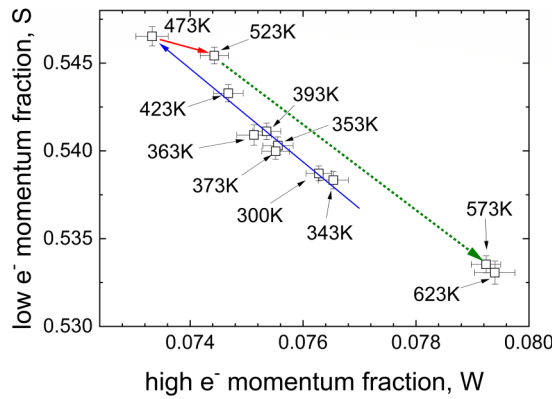


FIG. 4. S - W plane at a fixed energy ($E_p = 1.5$ keV) of incident positrons. The arrows guide the eye and follow the temperature development. Three distinct slopes, and hence vacancy-impurity complexes, are identified.

9 nm. For all samples, the observable changes take place in a range of about ≈ 170 nm (see Fig. 3). This is sufficient to dominate the RF performance, since the effective London penetration depth λ_L at 2 K is about 39 nm for pure niobium and up to 200 nm for niobium in the Pippard limit, which refers to a niobium with an interstitial concentration resulting in a mean-free path ℓ smaller than the coherence length ξ_0 [56]. No significant changes were observed during baking up to 353 K. Only annealing at temperatures above 353 K has a significant influence. All samples showed an steady increase (decrease) of the S (W) parameter during the baking for 4 h up to 473 K, respectively (Figs. 2 and 4). In the S (time) and W (time) curves the influence of ramping up (down) is evident but the final values at the respective temperature stages are larger (smaller) than the preceding steps. Moreover, during the 4 h dwell time a kinematic evolution of S and W is noticeable, evidencing a raise in open volume. For larger temperatures an opposite trend dominates and S (W) parameters nonmonotonically decrease (increase), which is a fingerprint of defect density drop and a change of its type. All S - W values are on the same line up to 473 K (Fig. 4). However, annealing at 523 K resulted in a change of slope in the S - W plot and a shift to higher W values, indicating a change in the nature of positron annihilation sites. This change coincides with the dissolution of the Nb_2O_5 layer as seen with XRR; see Fig. 1. Further annealing to 573 K resulted in additional increase of W accompanied by a decrease of S . This change remains after cooling down to room temperature and further exposure to air, as shown in Fig. 5. It testifies to the formation of a new stable defect type compared to the status before the annealing.

In Fig. 3 all depth profiles acquired at the RT intervals in between of the successive annealing stages are highlighted. For $E_p < 2$ keV a fast S decrease is observed which originates from the surface oxide states. In the range of $8 < E_p < 2$ keV a steplike plateau region is visible, which steadily decreases in magnitude to the Nb-bulk state for larger E_p . For temperatures up to 473 K the step becomes more convex, turning afterwards to a more flat level closer to the Nb-bulk value of S at 573 K. The change of S between 523 and 573 K is noticeably more abrupt than for preceding temperatures, as nicely presented

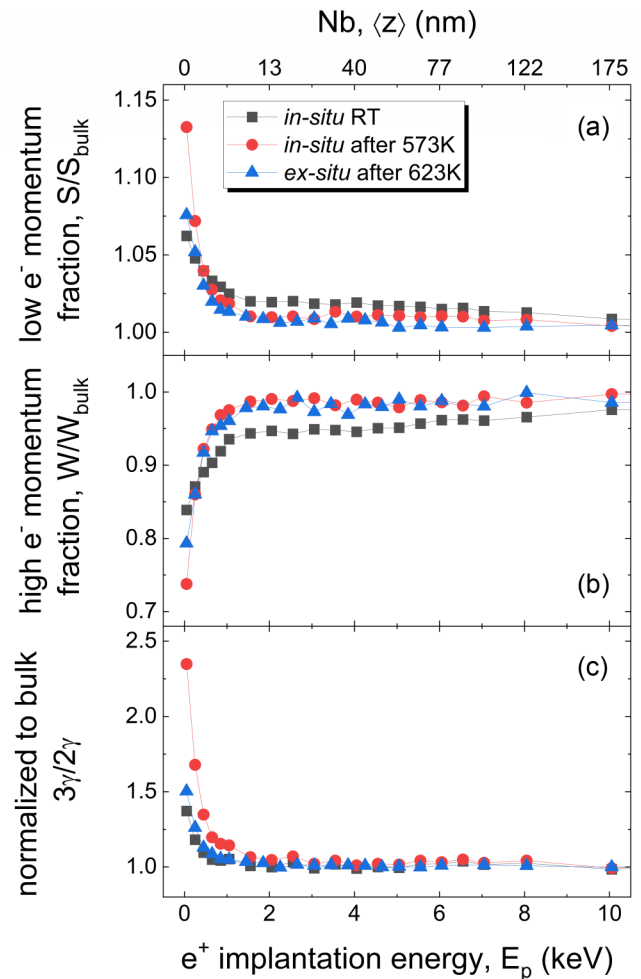


FIG. 5. Normalized to the bulk value annihilation line parameters S and W , as well as the $3\gamma/2\gamma$ ratio, as a function of the incident positron energy E_p . The curves show the *in situ* AIDA measurement at room temperature (RT) before annealing (black), after annealing at 573 K measured still *in situ* at RT (red), and the *ex situ* measurement at RT after annealing at 623 K and subsequent exposure to air (blue).

in Fig. 4, too. Finally, the $3\gamma/2\gamma$ ratio for the positron energy $E_p = 1.5$ keV is shown in Fig. 2. Up to 473 K only a small linear drift can be seen, which is due to surface cleaning effects. At 523 K an increase of $3\gamma/2\gamma$ ratio is observed, which can be explained as thermally activated release of positrons trapped in the surface image potential. This is further supported by the fact that the $3\gamma/2\gamma$ ratio returns to its initial value before the anneal when the sample is *in situ* cooled down to room temperature. At 573 K a significant increase of $3\gamma/2\gamma$ ratio was detected. After the heating period when the sample was cooled down to room temperature, the $3\gamma/2\gamma$ ratio decreased again but still remained higher compared to the value before annealing. Similarly to what occurs in the annealing at 523 K, thermally activated release of positrons trapped at the surface potential well occurs also during annealing at 573 K. But the remaining increased $3\gamma/2\gamma$ ratio in the sample cooled down to room temperature showed that in addition to the release process a real change in the chemistry of the near-surface region occurred. This is further confirmed by the fact that, even after the sample was exposed to air and remeasured, the $3\gamma/2\gamma$

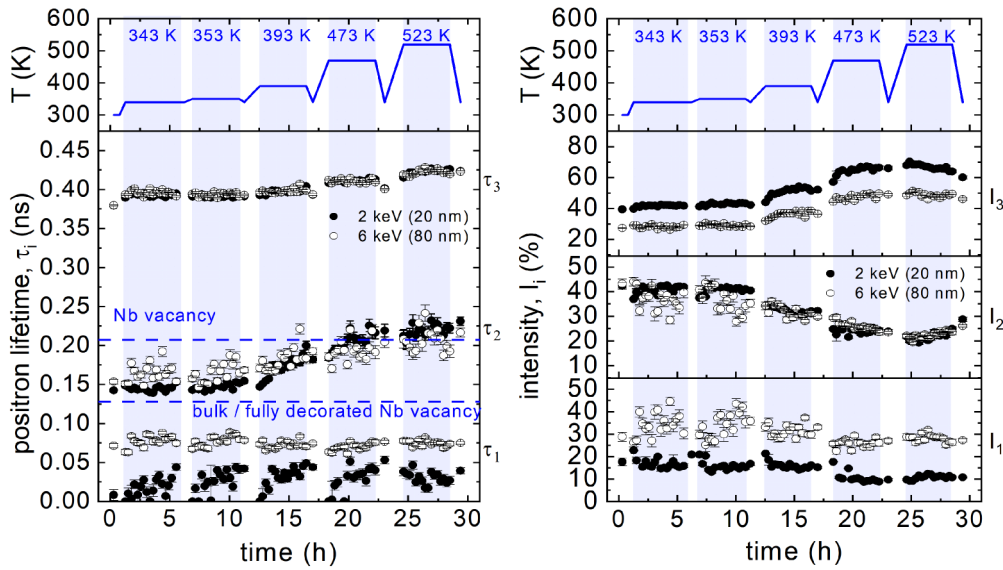


FIG. 6. Positron lifetimes τ_i (left) and corresponding intensities I_i (right) of components resolved in positron lifetime spectra plotted as a function of the measurement time for $E_p = 2$ keV (closed circles) and $E_p = 6$ keV (open circles). A sketch of temperature variations during the experiment is shown in the top layer of both figures and the blue areas indicate the temperature sequences.

ratio in the subsurface region with depth of $\langle z \rangle \approx 9$ nm ($\langle z \rangle$ at $E_p = 1.5$ keV) stayed above the value determined before the initial annealing, as shown in Fig. 5(c).

C. *In situ* variable energy positron annihilation lifetime spectroscopy (VEPALS)

In order to better compare with the *in situ* DB-PAS (2) and discuss the data, *in situ* PALS measurements for positron energies of $E_p = 2$ keV (penetration depth ≈ 14 nm) and $E_p = 6$ keV (penetration depth ≈ 82 nm; not affected by surface effects) are presented simultaneously. For the discussion, the results for all temperatures are shown in one plot. The effects of temperature and annealing time are visible. Parameters of each component (lifetime and intensity) are discussed individually, and the overall result is shown in Fig. 6.

The reduced bulk lifetime τ_1 represents positron annihilation at interstitial crystal positions and stays almost constant at around 40 ps for the near-surface region ($E_p = 2$ keV) and at about 70 ps for a deeper region ($E_p = 6$ keV). The intensity I_1 is almost constant for $T < 473$ K, and slightly decreases for $T > 473$ K, both close to the surface and deeper in the sample. In the case of $E_p = 2$ keV, the intensity I_1 slightly increases at the beginning of each annealing sequence (besides 523 K). This might be related to surface cleaning effects since it was not observed at larger implantation depths (6 keV). On the other hand, the fluctuations at 2 keV are mainly due to the short lifetime values, which are close to the detector resolution limit. For that reason, a more detailed discussion of the lifetime τ_1 for $E_p = 2$ keV is difficult.

The second component with lifetime τ_2 stays almost constant at around 150 ps for $T < 393$ K, indicating that Nb contains vacancies decorated by multiple hydrogen atoms (as shown in [57]). For annealing temperatures larger than 393 K the lifetime almost monotonically increases towards the value for a bare Nb vacancy, revealing gradual release of hydrogen atoms from their complex with the vacancy. This behavior

is similar for the near-surface region ($E_p = 2$ keV) and the deeper region ($E_p = 6$ keV). The intensity I_2 (which is a measure of vacancy concentration) shows a similar behavior: it remains constant up to 393 K and decreases for larger temperatures. It indicates that hydrogen removal is accompanied with annealing of single vacancies. However, at 523 K I_2 slightly increases, indicating an onset of a different physical process since hydrogen has been removed already.

The third component with lifetime τ_3 represents a contribution of positrons annihilated on the surface and positrons trapped at larger point defects (vacancy agglomerations). The lifetime τ_3 is almost constant for $T < 393$ K and increases for larger temperatures. As discussed in Ref. [57], this can only be explained by hydrogen release from vacancy clusters (analogous to the lifetime behavior of the decorated vacancies). At 523 K the lifetime τ_3 decreases for a positron energy of $E_p = 2$ keV (also very little for $E_p = 6$ keV), again indicating an onset of a different physical process, that is more pronounced in the near-surface region. The intensity I_3 increases for $T > 353$ K. Considering the behavior of intensity I_2 (simultaneous decrease), it can be explained by an overall decrease of the concentration of vacancy-type defects (Nb vacancy) and simultaneous increase in the concentration of vacancy clusters; i.e., after detachment of hydrogen, vacancies agglomerate into clusters. The vacancy agglomerations are mostly expected in the oxide layers in the region nearest the surface, as suggested by the XRR (Fig. 1) and DB-VEPAS measurements (Fig. 3).

D. Kerr microscopy

Surface magnetic order can be observed in dielectric oxides and it is assumed that this is due to oxygen vacancies [1–3]. Hence, we studied the magnetic order of several samples within the first 15 nm at room temperature using Kerr microscopy as complementary method to the positron spectroscopy. The magnetic field was applied parallel to the

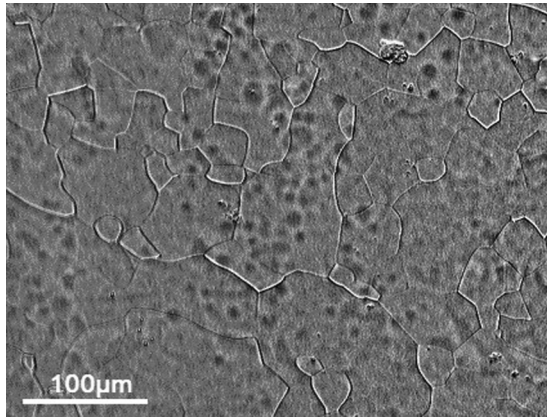


FIG. 7. Kerr image taken at 200 mT. Brighter areas are domains with a magnetization antiparallel to dark areas. The grain boundary structure is clearly visible as continuous lines. A spotted multidomain structure ($d < 10 \mu\text{m}$), overlaying the grain boundaries and randomly distributed, is observed.

surface, which is the case under operation conditions of a superconducting cavity. Figure 7 shows a single image taken with the Kerr microscope. The image displays a formation of a multidomain structure ($d < 10 \mu\text{m}$) distributed across the sample surface, independent of grain boundaries. Furthermore, by scanning the focal plane of the microscope, the origin of this multidomain structure was identified within the niobium oxide layer. This observation was found for all samples investigated.

E. *Ab initio* calculations

In-detail calculations, leading to the results shown here are given in the Appendices. Calculated binding energies $E_{B,v-X}$ of H, N, O to a vacancy are summarized in Table II, indicating that oxygen is bound to a vacancy more strongly than to hydrogen. On the other hand, the binding of nitrogen to a vacancy is weaker compared to hydrogen. The calculated bond length, i.e., the distance of a gas atom from the vacancy, d_{v-X} , is shown in Table II as well. Hydrogen is in the closest vicinity of a vacancy, in contrast to the loosely bounded nitrogen located the largest distance from the vacancy. The oxygen-vacancy distance is found to be between those for H and N. Complexes of vacancies with H, N, O impurities are capable of positron trapping. However, the lifetime of trapped

TABLE II. Calculated lifetimes τ of positrons trapped at vacancies and complexes of vacancies with H, N, O gas impurities. All these impurities are trapped at vacancies. Calculated binding energy $E_{B,v-X}$ of gas impurity X to vacancy and bond length d_{v-X} , i.e., distance of impurity X from vacancy, are listed in the table as well.

| Defect | τ (ps) | $E_{B,v-X}$ (eV) | d_{v-X} (Å) |
|--------|-------------|------------------|---------------|
| v | 207 | | |
| v-H | 199 | -0.57 | 1.43 |
| v-N | 190 | -0.37 | 1.57 |
| v-O | 188 | -0.83 | 1.53 |

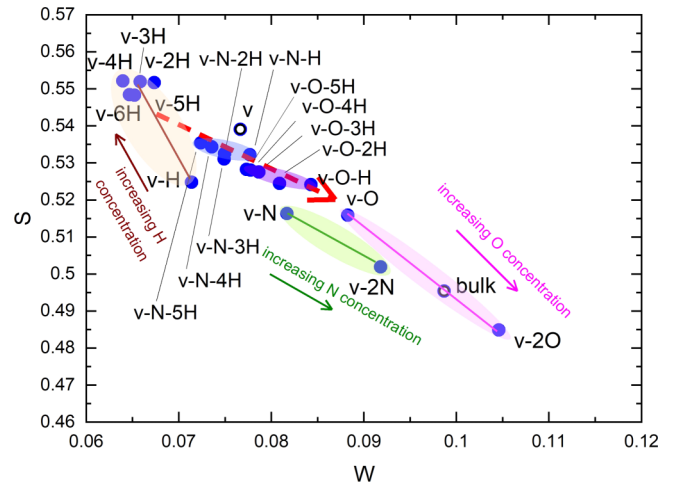


FIG. 8. Correlation S - W plot of S and W parameters calculated for positrons delocalized in a perfect Nb lattice (bulk) and positrons trapped in various defects. Filled areas indicate regions in the S - W plane where various families of vacancy-impurity complexes are located, namely $v-n\text{H}$, $v-n\text{N}$, $v-n\text{O}$, $v-n-n\text{H}$, and $v-n\text{O}$.

positrons is shortened with respect to a bare vacancy due to a reduced positron localization and increased electron density in the vacancy. Calculated lifetimes of positrons trapped in v-H, v-N, and v-O complexes are also listed in Table II. The shortening of the positron lifetime becomes more pronounced with an increasing number Z of protons of the impurity atom; i.e., the shortest lifetime was found for the v-O complex.

Up to six hydrogen atoms can be trapped in a single vacancy, forming $v-n\text{H}$ complexes. The lifetime of positrons trapped in $v-n\text{H}$ complexes gradually decreases with increasing number of H atoms; see Fig. 14. Up to 2 N or O atoms can be trapped in a vacancy. For a higher number of N or O atoms the complex becomes unstable. Lifetimes of positrons trapped in v-2N and v-2O complexes are 155 and 166 ps, respectively, i.e., significantly shorter compared to v-N and v-O.

Calculated momentum distributions of annihilating electron-positron pairs plotted in Figs. 19 and 22 show that the positrons annihilated in the vicinity of N atoms leads to a peak located at $p_L \approx 20 \times 10^{-3} m_0c$ due to contribution of nitrogen p electrons. This peak is even more pronounced for oxygen, which contains one more p electron. On the other hand, this peak is not present for a vacancy associated with H atoms due to lack of p electrons; see Fig. 15. Because of the peak at $p_L \approx 20 \times 10^{-3} m_0c$ in the momentum distribution, positrons trapped in a v-N complex exhibit an enhanced contribution in the high momentum range compared to v-nH complexes. For v-O complexes, this high momentum contribution is enhanced even more. Hence, positron trapping in v-O or v-N complexes will result in a higher W parameter compared to v-nH complexes. For the sake of comparison with the experiment, the S and W parameters were calculated by integration of the calculated momentum distribution curves in the low and high momentum ranges and are shown for a perfect Nb lattice and various defects in a S - W correlation plot in Fig. 8. Note that agreement of calculated S and W parameters with experiment is only qualitative due to limited accuracy of calculation of momentum distribution using

atomic orbitals and also because in real sample only fraction of positrons is trapped at defects while others are annihilated in the free state. Nevertheless, calculated S , W parameters are useful for interpretation of trends observed in experiment.

IV. DISCUSSION

The XRR measurements showed that the Nb_2O_5 layer on Nb(100) completely dissolves at 523 K already after 1 h annealing. Further, at 573 K after 50 min the NbO_2 layer decomposes entirely into NbO [58]. At the same time, the diffuse scattering signal from interstitial oxygen measured by XRD in the near-surface region is decreasing drastically [34,58]. This result is in agreement with [59], where it was shown on polycrystalline fine-grain niobium that heat treatment around 573 K for a few hours is accompanied by an influx of oxygen at 0.1 at.%. This general agreement is important, as the XRR and XRD measurements were done on single crystal samples, and the diffusion in niobium is grain boundary dominated. It is possible that the exact temperature at which the Nb_2O_5 layer dissociates depends on the grain orientation and could also be affected by the existence of grain boundaries. The fact that on fine-grain samples the nature of the vacancy complexes change between 473 and 523 K indicates that the results of the XRR measurements from the Nb(100) sample are substantial enough to further discuss and interpret the observed effects in the positron annihilation spectroscopy measurements.

The S - W plot from Fig. 4 can now be easily understood, taking into account the calculated S and W values from Fig. 8 and the XRR results. As shown in [57], the data points on the line up to 470 K are vacancy-hydrogen complexes that start to dissociate above 343 K, which is a critical temperature for the Nb-H system [60]. Above 473 K, the decomposition of the Nb_2O_5 layer releases O atoms, which diffuses into the Nb subsurface region. From the inspection of Fig. 8 it is clear that v-O complexes are characterized by the S parameter comparable to v-H complexes but exhibit a remarkably larger W parameter. Hence, the shift of the experimental S - W points in Fig. 4 to larger W values occurring after annealing at 523 K can be explained by oxygen trapping at vacancies, i.e., transformation of v-H (or v) to v-O complexes. Hence, during the annealing of the Nb samples the nature of vacancy-type defects changes in the sequence v-nH ($T \leq 420$ K) \rightarrow v ($420 < T \leq 470$ K) \rightarrow v-O ($T \geq 520$ K) as indicated by the dashed line in Fig. 8. The *ab initio* calculations also revealed that O atoms are bound to vacancies stronger than hydrogen. Therefore, H is prevented from returning to those positions in the lattice once the niobium cools down after annealing. This is another interesting observation, as hydrogen at vacancies act as niobium hydride nucleation centers when cooling down to cryogenic temperatures, which then causes an increase of the surface losses [57,61,62].

Using the results of *ab initio* calculations, the experimental lifetime τ_2 corresponding to positrons trapped at various types of vacancy defects (Fig. 6) can be easily discussed. At temperatures below 390 K, τ_2 corresponds to a lifetime of positrons trapped in vacancies associated with multiple H atoms, whereas above 390 K τ_2 gradually increases towards the lifetime for a bare vacancy. It indicates that, during an-

nealing at temperatures above 400 K, hydrogen atoms are gradually released from vacancies.

Since niobium is arranged in a bcc lattice, and the first native oxide layer on top, NbO, is ordered in an fcc arrangement, a misalignment when stacking those two unit-cells onto each other appears. Depending on the atomic radius of the participating elements, the layer thickness, Nb-lattice orientation, internal stress and growth temperature, energetic optimal misalignment angles exist. For fcc-bcc interfaces, three orientations are predicted by the rigid-lattice theory and observed for many metal on metal systems; e.g., for Nb(100) the optimal in-plane relation to the NbO(110) cell results in a tilt of 5.26° between the rows of $[101]_{fcc}$ with respect to $[001]_{bcc}$ [58,63–65].

Measurements conducted by Delheusy *et al.* [58] show that the in-plane orientation of this interface for regular niobium used for SRF applications prior to any anneal does not show the optimal relation: the NbO layer is not fully structured, nor is the orientation close to the optimal angle. According to these studies, only an annealing at temperatures around 570 K provides enough thermal energy that the interface reorganizes itself in such a way that it aligns closer to the theoretical optimum. Additionally, the lattice transition changes by creating an intermediate Nb_2O layer as a buffer between the Nb and NbO lattices. An important consequence of the reduction of the lattice mismatch is that the vacancy concentration decreases in the niobium-oxide layer. This may have an impact on the detailed density of states (DOS), which may be phenomenologically represented by the so-called Dynes states. Dynes states help describe a realistic superconducting gap, where those states may arise from pair-breaking scattering [4,28,66]. Hence a reorganization and reduction of scattering sites will improve the ordering of the superconductor and should increase the superconducting gap. This is in agreement with the observed increase of the $\frac{\Delta}{k_B T}$ ratio measured on Nb cavities after the mid-T bake [22,32,67]. The onset of the overall defect density decrease in the subsurface region is found at 523 K already according to our DB-PAS (Fig. 2) and PALS (Fig. 6) investigations, too.

Ma *et al.* [68] annealed niobium samples and made the same observations as Delheusy *et al.* [58] and Semione *et al.* [34], that the Nb_2O_5 layer is dissolved at ≈ 550 K and that a Nb_2O layer forms. Furthermore, from XPS measurements the reorganization and formation of the Nb_2O layer accompanied by the occurrence of a new state in the valence band was evidenced [68].

Although the Nb_2O_5 -layer is polymorphous, structures (on the order of 10 nm) are observed with their symmetry matching that of the underlying nanocrystals, which are strongly influenced by the structural and electronic properties of the underlying NbO substrate [69]. Hence, a reorganization of the NbO layer as seen by Ma *et al.*, Delheusy *et al.*, and Semione *et al.* and the subsequent regrowth of the Nb_2O_5 layer after the annealing on the newly ordered oxide will yields different vacancy concentrations and properties for the pentoxide. Since it has been shown that oxide vacancies can cause surface magnetism [1–3], we inspected the surfaces of samples to test whether such an effect is observable. Indeed a multidomain structure originating from niobium oxide was identified. This is strong support for the existence of magnetic

impurity and agrees with the conclusions and observations above, as a further impact on DOS is caused by magnetic impurities. A recent *ab initio* study by Sheridan *et al.* and comparison to x-ray absorption spectrum measurements by Harrelson *et al.* fully agree with our conclusions [70,71]. In these reports, they confirm the presence of magnetic moments in the niobium oxides, caused by oxygen vacancies.

Impact on accelerator performance. The RF loss of a cavity, given by the surface resistance R_s , is usually interpreted as the sum of two contributions:

$$R_s = R_{BCS}(E_{acc}, T) + R_{res}(E_{acc})$$

with R_{BCS} being the contribution derived by the microscopic theory of superconductors and R_{res} the residual resistance stemming from, e.g., scattering processes on lattice defects or interstitials, dielectric losses in the native oxide, and electric interface losses or trapped magnetic flux.

The correlation between RF induced losses and the existence of magnetic impurities, according to the Shiba theory [72], was shown by Proslir *et al.* [6] already. Accompanying theoretical work showed that an inherent nonzero residual resistance R_{res} is a consequence of magnetic impurities in the RF penetration layer [7] and, in general, the cause of any existing subgap states regardless of the microscopic origin. A more recent approach by Kubo *et al.* discusses different realistic surfaces, including Dynes subgap states and magnetic impurities in the material, further showing their potential to minimize RF losses and to modify the dynamic loss mechanisms if tailored accordingly [9,28]. Hence, the proof of existence of magnetic domains in the oxide by the Kerr microscopy and the vacancy dynamics as shown above by the PALS measurement are well aligned with previous findings, and allow the microscopic identification of the origin of the magnetic impurities to be oxygen vacancies.

Another reduction of the RF induced losses at higher accelerating fields is possibly caused by the vacancy dynamics within the niobium. The annealing of niobium reduces the amount of vacancies in the near-surface region and also dissociates the hydrogen from those vacancies, which then are occupied by oxygen. Trapping of hydrogen on interstitial oxygen has been shown to be possible by our *ab initio* calculations and also in [73], and was already used as a model to explain internal friction resonances in [74]. It is known that hydrogen trapped at vacancies can act as nucleation site of niobium hydrides upon cooling. Assuming that the formation of niobium hydrides is suppressed once hydrogen is then trapped at interstitial oxygen, a reduction of lossy nanohydrides, and hence a reduction of the residual resistance at higher accelerating fields, is then the evident consequence.

Impact on quantum computing. Cavities have an inherently a higher photon lifetime, due to the design and material used, by three orders of magnitude compared to other designs of qubits, offering a new approach in quantum computer design. In the work by Romanenko *et al.* [20,21], the origin of the two-level systems reducing the photon lifetime were speculated to be within the oxide layers, although no further discussion of their microscopic origin was given. The work by Sheridan *et al.* and Harrelson *et al.* [70,71] suggest that oxygen deficient Nb_2O_5 layers are a significant source of the reduced coherence lifetime. In agreement with our findings

of the reduced oxygen vacancies, the photon lifetime was improved for cavities which were annealed at 613 K.

V. CONCLUSION

In our study we investigated the dynamics of vacancies in niobium and its native oxide layer under annealing up to 573 K. Our results provide microscopic explanations of multiple observations from various research fields. The existence of magnetic impurities, caused by oxygen vacancies, are of interest for quantum computing application, and our findings suggest that a reorganization of the oxide layer, from which this application benefits, takes place during the anneal.

In order to improve niobium surfaces for accelerating cavities, it is mandatory to fully understand the origin of various loss contributions. The contribution to the residual resistance by magnetic impurities, caused by oxygen vacancies, can be manipulated by the anneal of Nb SRF cavities in the temperature range 573–673 K. At the same time, the observation of the vacancy-hydrogen complex dissociation and the formation of vacancy-oxygen complexes have a substantial impact on the interstitial hydrogen concentration. Hence, a reduction of the lossy nanohydrides and also the BCS resistance can originate from these processes, further explaining the improvements seen by the annealing.

ACKNOWLEDGMENTS

The authors of this work thank A. Ermakov and S. Sievers (DESY) for their support in the preparation of the samples. The DESY affiliated authors acknowledge support from DESY (Hamburg, Germany), a member of the Helmholtz Association HGF. Positron annihilation lifetime studies were carried out at the ELBE facility at the Helmholtz-Zentrum Dresden-Rossendorf. The authors thank the facility staff for their assistance. The authors also thank the ESRF for the granted beam time to carry out the x-ray reflectivity measurements. The UHV-induction annealing of the Nb crystals used in the XRR measurements by T. Meisner and A. Weible at the MPI for Intelligent Systems is acknowledged. This work was supported by the BMBF under the research Grant No. 05H18GURB1, the Impulse-und Networking fund of the Helmholtz Association (VH-VI-442 Memriox), and the Helmholtz Energy Materials Characterization Platform (03ET7015). Computational resources for the DFT calculations were supplied by the project “e-Infrastruktur CZ” (e-INFRA LM2018140) provided within the program Projects of Large Research, Development and Innovations Infrastructures.

M.W. conceived the idea and the study, performed experiments, analyzed data, wrote the manuscript, and supervised the project. J.C. carried out DFT calculations, analyzed data, and wrote the manuscript. M.O.L. performed PALS and PAS experiments, analyzed data, and wrote the manuscript. M.B. performed PALS experiments, analyzed data, and wrote the manuscript. M.S. carried out Kerr microscopy and analyzed data under supervision of M.A. G.D.L.S. prepared samples, carried out the x-ray reflectivity measurements, and analyzed data under supervision of A.S. Co.B. carried out Kerr microscopy. C.B. prepared the samples and performed

experiments. O.M. carried out DFT calculations. E.H. performed PALS experiments and contributed to the experimental design. A.W. contributed to the experimental design performed PALS experiments. H.W., A.S., M.A., and W.H. contributed to the experimental design, discussed results, and reviewed the manuscript.

The authors declare no competing interests.

APPENDIX A: SURFACE TREATMENT OF SAMPLES

The baseline treatment for the samples were

(1) Electropolishing (EP) with a total removal of 120 μm surface layer.

(2) Ultrasonic cleaning and high pressure rinsing (deionized water at 100 bar).

(3) 1073 K annealing for 3 h at a pressure below 10^{-5} mbar.

(4) Electropolishing with a total removal of 30 μm surface layer.

(5) Ultrasonic cleaning and high pressure rinsing (deionized water at 100 bar)

The electropolishing was done with HF ($w = 40\%$) and H_2SO_4 ($w = 98\%$) acids mixed in the volume ratio 1:9. Dedicated sample chemistry and high pressure rinsing holders were developed to use the standard infrastructure for cavity treatment at DESY. The final preparation step, the annealing, was then studied *in situ* using methods described above.

APPENDIX B: DETAILS ON POSITRON ANNIHILATION SPECTROSCOPY

The Doppler shift of the annihilation radiation is determined by the momentum of the electron which annihilated the positron. In DB spectroscopy, the broadening of the annihilation photopeak is characterized in terms of the line shape parameters S (sharpness) and W (wing), which contain information about the contributions of annihilation by low or high momentum electrons, respectively. The S parameter is defined as the ratio of the central area A_1 of the annihilation photopeak to the total peak area A_{total} ; see Fig. 9. In the present work, the energy range $\delta E = \pm 0.93$ keV around the annihilation peak was used for calculation of the S parameter. Positrons annihilated by free electrons, which on average have a low momentum, contribute to the central region of the annihilation photopeak. An increase of vacancies will lead to a higher fraction of positrons getting trapped and annihilated by free electrons in these vacancies and therefore cause an increase of the S parameter. The W parameter is the fractional area in the wing regions A_2 (508.56 ± 0.35 keV) and A_3 (513.44 ± 0.35 keV), and represents a measure of positrons annihilated by core electrons of the surrounding elements. The core electrons have on average a higher momentum, causing an element-specific contribution in the momentum distribution. Hence, the correlated measurement of S and W parameters is sensitive to the type and the atomic environment of positron trapping sites or defects in the material. Plotting S and W parameters as a trajectory in the S - W plane provides a powerful approach to interpret the depth profiling data. In samples containing a single type of defects, the points

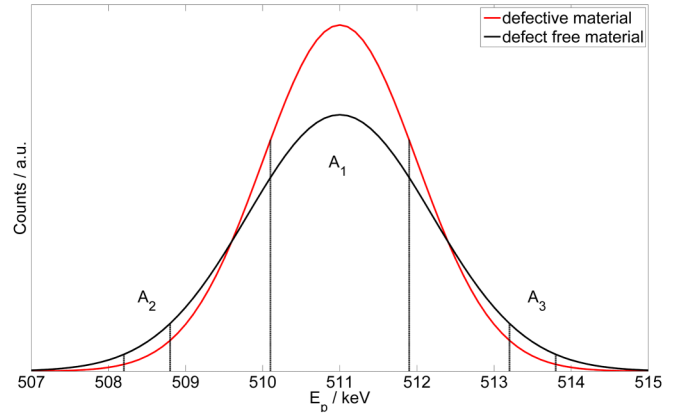


FIG. 9. Positron annihilation photopeak in a metallic material. The central area A_1 is used to quantify the S parameter, while the areas A_2 and A_3 are used for the W parameter. Changes in the density, type, and chemical environment of positron traps change the momentum distribution of electrons annihilating positrons and hence lead to different values of the S and W parameters.

generally fall on a line segment because only two states of positrons (free positron and positron trapped at a defect) are formed. The measured S and W represent a superposition of contributions from these states and fulfill a linear relationship

$$(S - S_{bulk}) = R(W - W_{bulk}) \quad (\text{B1})$$

with a defect-specific slope R [75]. The symbols S_{bulk} and W_{bulk} stand for the S and W parameters of a defect-free sample of the same material. In the case of slow positron beam experiments the positrons are implanted into films with defined kinetic energy E_p , typically in the range of few tens of eV up to several tens of keV, which enables depth profiling. A mean positron implantation depth can be approximated by a simple material density dependent formula [76],

$$\langle z \rangle = \frac{A}{\rho} E_p^n, \quad (\text{B2})$$

where $A = 36$ and $n = 1.62$ are empirically acquired values and ρ is the material density.

Positrons implanted into solids may form a hydrogenlike bound state with an electron, called positronium (Ps) [77,78]. Ps is formed on external or internal surfaces of solids by a thermalized positron picking an electron on the surface and escaping from the solid into a pore or free space [79]. Depending on the orientation of electron and positron spin in the bound state, Ps decays in two photons (para-Ps, singlet state) or three photons (ortho-Ps, triplet state). In solids the three-photon decay of ortho-Ps is suppressed due to pick-off annihilation (two photon decay) with an electron with opposite spin from the environment [80,81]. Three photon decay can be suppressed also by a magnetic field [82–85], in particular by ortho-to-para conversion of Ps in the vicinity of paramagnetic species. Hence, the ratio $3\gamma/2\gamma$ is sensitive to the chemical environment of the Ps atom.

APPENDIX C: DETAILS ON THE AB INITIO CALCULATIONS

Since hydrogen is a light atom, vibrational energy of hydrogen ions in the Nb lattice has to be considered. Zero-point energy (ZPE) of hydrogen was calculated using the Einstein model for localized hydrogen modes, i.e., by summing up the vibration energies of hydrogen normal modes, $ZPE = \frac{1}{2} \sum_i h\nu_i$, where h is the Planck constant. The vibration frequencies ν_i were determined from the energy versus displacement curves of hydrogen atoms.

Positron annihilation observables were calculated using DFT within the so-called standard scheme [49]. In this approximation, the positron density is assumed to be negligibly small everywhere and not affecting the bulk electron structure. At first, the electron density $n(\mathbf{r})$ in the material is solved without the positron. Subsequently, the effective potential for a positron is constructed as

$$V_+(\mathbf{r}) = \phi(\mathbf{r}) + V_{corr}[n], \quad (C1)$$

where $\phi(\mathbf{r})$ is the Coulomb potential produced by the charge distribution of electrons and nuclei and V_{corr} is the zero positron density limit of the electron-positron correlation potential [49]. The ground state positron wave function was calculated by a numerical solution of the single particle Schrödinger equation

$$-\frac{1}{2}\nabla^2\psi_+(\mathbf{r}) + V_+(\mathbf{r})\psi_+(\mathbf{r}) = E_+\psi_+(\mathbf{r}), \quad (C2)$$

where E_+ is the positron ground state energy.

The positron lifetime τ was calculated from the overlap of the positron density $n_+(\mathbf{r}) = |\psi_+(\mathbf{r})|^2$ and the electron density $n(\mathbf{r})$ using the expression

$$\frac{1}{\tau} = \pi r_e^2 c \int n_+(\mathbf{r})n(\mathbf{r})\gamma[n] d\mathbf{r}, \quad (C3)$$

where r_e is the classical electron radius, and c is the speed of light. The electron enhancement factor γ accounts for the pileup of electrons at the positron site [49]. The electron-positron correlation potential and the enhancement factor were treated within local density approximation (LDA) using the parametrization by Boroński and Nieminen [86]. A Brillouin-zone integration over the lowest-lying positron state [87] was used in the calculations of the positron density for vacancies to achieve rapid convergence of the results with respect to the supercell size.

The momentum distribution of the annihilating electron-positron pairs was calculated using the approach described in Refs. [50,51]. The contribution $\varrho^{i,Nl}$ from the i th atom and a shell characterized by the principal and orbital quantum numbers N, l was calculated by the formula

$$\varrho^{i,Nl}(p) = 4\pi^2 r_e^2 c N_e^{i,Nl} \gamma^{i,Nl} \left| \int R_+^i R_-^{i,Nl} B_l(pr) r^2 dr \right|^2, \quad (C4)$$

where $N_e^{i,Nl}$ denotes the number of electrons in the (N, l) shell, B_l is a spherical Bessel function and $R_+^i, R_-^{i,Nl}$ denote the radial part of the positron and electron wave functions. A state-dependent positron enhancement factor $\gamma^{i,Nl}$ is used in the calculation [51]. The momentum distribution of the annihilating electron-positron pairs was obtained by summing the partial contributions $\varrho^{i,Nl}(p)$ over all the occupied atomic sites

and filled electron shells. Since the core electrons localized in atomic shells are practically not affected by crystal bonding and retain their atomic character, the present approach describes well the high-momentum part of the momentum distribution ($p > 10^{-3} m_0 c$), where the contribution of positrons annihilated by core electrons dominates. To mimic the effect of the finite resolution of the experimental setup, the theoretical momentum distribution curves were convoluted with a Gaussian function with a FWHM of $3.5 \times 10^3 m_0 c$. For the sake of comparison with the experiment, the calculated momentum distributions are presented as ratio curves related to the momentum distribution calculated for a perfect Nb crystal. Calculations of positron observables were always performed for relaxed geometries of defects obtained from VASP calculations.

1. Pure Nb

As a benchmark, we calculated the bulk positron lifetime, i.e. lifetime of a positron delocalized in a perfect (defect-free) Nb lattice of 128 ps. This value is in good agreement with experiment [38].

The formation energy of a vacancy in Nb was calculated from the expression

$$E_{f,v} = E[N-1, v] - \frac{N}{N-1} E[N, \text{bulk}], \quad (C5)$$

where $E[N, \text{bulk}]$ is the total energy of a perfect supercell consisting of $N = 128$ Nb atoms and $E[N-1, v]$ is the energy of a supercell containing a vacancy. The calculated vacancy formation energy $E_f = 2.79$ eV is in good agreement with the value of 2.71 eV calculated by Ford *et al.* in Ref. [88] as well as with experimental values reported in literature, falling into the range 2.7-3.0 eV [89,90]. The eight nearest neighbouring Nb ions surrounding the vacancy relax towards the vacancy. Their displacement from the rigid lattice sites is 0.13 Å. Fig. 10(a) shows the calculated positron density in the (001) plane containing a vacancy. The positron is confined in a vacancy and the positron density has a spherical symmetry with its center in the vacancy. Calculated lifetimes of a positron trapped in a vacancy is 207 ps. This calculated value is also in good agreement with the experimental lifetime of (210 ± 2) ps reported in literature [91].

2. Hydrogen in Nb

The lowest energy site of a hydrogen absorbed in the Nb lattice is the tetrahedral interstitial site. The Nb lattice around a hydrogen interstitial (H_i) is locally expanded. As shown in Fig. 11, Nb ions around H_i are displaced in the direction away of the hydrogen. The calculated displacement of the four nearest neighbour Nb ions surrounding H_i is 0.08 Å.

The formation energy of H_i , i.e. absorption energy for hydrogen in the tetrahedral site, was calculated as

$$E_{f,H_i} = E[N, H_i] + ZPE[H_i] - (E[N, \text{bulk}] + \frac{1}{2} ZPE[H_2]), \quad (C6)$$

where $E[N, H_i]$ is the total energy of the supercell containing hydrogen in the tetrahedral site, $ZPE[H_i]$ and $ZPE[H_2]$ denote the ZPE for a H_i and H_2 molecule, respectively. The

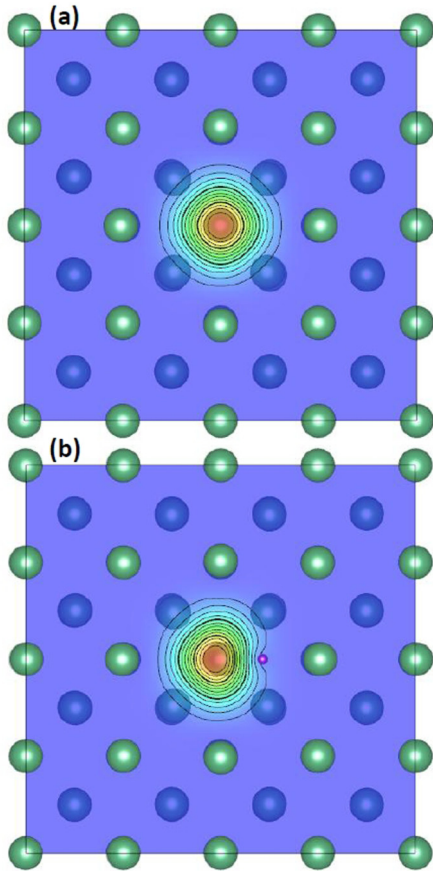


FIG. 10. Relaxed configuration of lattice ions and the calculated positron density in the (001) plane for (a) a vacancy, (b) a v-H complex.

hydrogen absorption energy was calculated using Eq. (C6) and the derived value $E_{f,H_i} = -0.29$ eV is in good agreement with previous *ab-initio* calculations [92], as well as with experimental data [93]. The negative value of E_{f,H_i} indicates that the hydrogen absorption in Nb is an exothermic process.

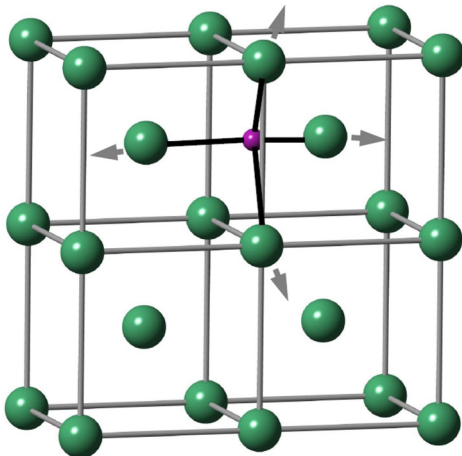


FIG. 11. Relaxed configuration of a hydrogen interstitial located in the tetrahedral interstitial site. Arrows show directions of ion relaxations.

The interaction of an interstitial hydrogen impurity with vacancies in Nb has been considered and it was found that there is an attractive interaction between H_i and the vacancy. Consequently, hydrogen is bound to a vacancy forming a so-called vacancy-hydrogen (v-H) complex. The lowest energy configuration of v-H complex is shown in Fig. 10(b). The hydrogen impurity is located on the line between the vacancy and the nearest neighbour octahedral interstitial site and is displaced 0.23 Å from the octahedral site towards the vacancy. Hence, the distance of hydrogen from the center of vacancy is 1.43 Å. The hydrogen binding energy to the vacancy was calculated from the expression

$$E_{B,v-H} = E[N - 1, v-H] + E[N, \text{bulk}] + ZPE[v-H] - (E[N - 1, v] + E[N, H_i] + ZPE[H_i]), \quad (C7)$$

where $E[N - 1, v-H]$ is the energy of the supercell containing a v-H complex in the lowest energy configuration and $ZPE[v-H]$ is the ZPE of hydrogen in the v-H complex. The calculated binding energy $E_{B,v-H} = -0.57$ eV is comparable to the binding energy calculated using the effective medium theory [94]. Note that a negative binding energy means that the attachment of hydrogen to a vacancy leads to a decrease of energy, i.e. hydrogen attached to a vacancy has a lower energy than hydrogen alone, located in tetrahedral interstitial site. Hence, hydrogen absorbed in Nb makes formation of vacancies easier. When the Nb lattice contains interstitial hydrogen, the vacancy formation energy is reduced to $2.79 - 0.57 = 2.22$ eV due to hydrogen binding to vacancy.

Figure 10(b) shows the calculated positron density in the (001) plane containing a v-H complex. Similarly to the bare vacancy, positrons are confined in a v-H complex, but the positron density exhibits a clear asymmetry due to repulsive interaction between the hydrogen ion and a positron. Hence, the calculated positron lifetime was reduced with respect to a bare vacancy down to 199 ps.

In many metals, vacancies are able to trap multiple hydrogen atoms forming $v-nH$ complexes [38,94–97]. For this reason, trapping of multiple hydrogen atoms in a Nb vacancy should be considered as well. The binding energy of additional hydrogen to a vacancy associated already with n hydrogen atoms leading to a transformation of a $v-nH$ complex into a $v-(n+1)H$ complex can be calculated as

$$E_{B,v-(n+1)H} = E[N - 1, v-(n+1)H] + E[N, \text{bulk}] + ZPE[v-(n+1)H] - (E[N - 1, v-nH] + E[N, H_i] + ZPE[v-nH] + ZPE[H_i]),$$

where $E[N - 1, v-(n+1)H]$ and $E[N - 1, v-nH]$ is the energy of supercells containing $v-(n+1)H$ and $v-nH$ complexes respectively, and $ZPE[v-(n+1)H]$, $ZPE[v-nH]$ are the corresponding ZPEs of hydrogen atoms attached to the vacancy. Calculated binding energies of hydrogen atoms to a vacancy are plotted in Fig. 12. In the lowest energy configuration, hydrogen atoms are always located on the lines between the vacancy and the nearest neighbour octahedral sites. Since there are six octahedral sites around a vacancy, the binding energy of hydrogen to a vacancy remains negative up to six atoms. Hence, a single vacancy is able to trap at least six

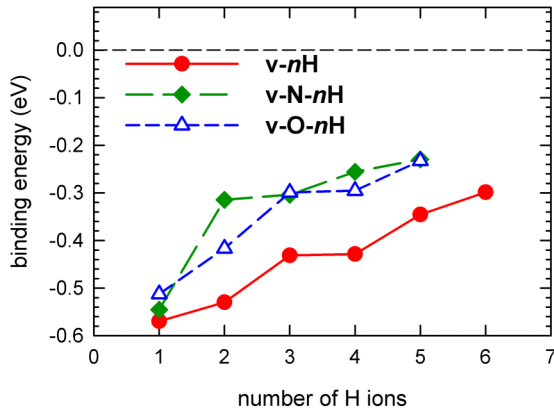


FIG. 12. Calculated binding energies of hydrogen atoms to a vacancy forming v - n H complexes and to vacancies associated already with N or O atoms forming v -N- n H or v -O- n H complexes.

hydrogen atoms forming v -6H complex. From an inspection of Fig. 12, it is clear that the absolute value of the hydrogen binding energy decreases with an increasing number hydrogen atoms attached to a vacancy. Hence, with an increasing number of hydrogen atoms the binding of an additional hydrogen atom becomes weaker and weaker due to a repulsive H-H interaction. Vacancies associated with n hydrogen atoms ($n \leq 6$) are still able to trap positrons. As an example, Fig. 13 shows the calculated positron density in the (001) plane for a v -2H and a v -4H complex. Although positrons are localized in v - n H complexes, deformations of the positron density due to the repulsion between positrons and hydrogen interstitials are clearly visible in Fig. 13.

Figure 14 shows calculated lifetimes of positrons trapped in v - n H complexes as a function of number n of H atoms bound to vacancy. Lifetime of trapped positrons gradually decreases towards the bulk positron lifetime with increasing number of H atoms attached to vacancy. The calculated momentum distributions of annihilating electron-positron pairs for v - n H complexes, presented as ratio curves with respect to defect-free pure Nb, are plotted in Fig. 15. The impact of hydrogen on the momentum distribution is relatively weak. Positrons trapped in v - n H complexes are responsible for slightly enhanced contribution at $p_L \approx 15 \times 10^{-3} m_0 c$. With an increasing number of hydrogen atoms, this contribution becomes more pronounced.

3. Nitrogen in Nb

Our *ab initio* calculations revealed that in contrast to hydrogen, nitrogen absorbed in the Nb lattice has lowest energy in the octahedral interstitial site. The Nb lattice is locally distorted around nitrogen interstitial (N_i) as shown in Fig. 16, where a relaxation of the two nearest neighbors of N_i is outward (displacement 0.39 \AA) while the four next nearest neighbours exhibit inward relaxation (displacement -0.11 \AA). The formation energy of (N_i) was calculated from the expression

$$E_{f,N_i} = E[N, N_i] - (E[N, \text{bulk}] + \frac{1}{2}E[N_2]), \quad (\text{C8})$$

where $E[N, N_i]$ is the energy of a supercell containing N_i in the octahedral position and $E[N_2]$ is the energy of the N_2

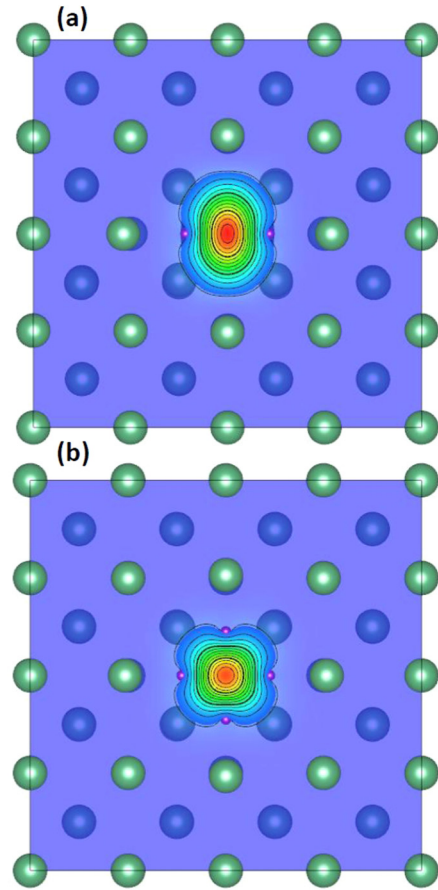


FIG. 13. Relaxed geometry of the lattice ions and the positron density in the (001) plane for (a) a v -2H complex, (b) a v -4H complex.

molecule. The negative formation energy $E_{f,N_i} = -1.74 \text{ eV}$ indicates that nitrogen absorption into the Nb lattice is an exothermic process. Similarly to hydrogen, interstitial nitrogen impurities in the Nb lattice can be trapped at a vacancy.

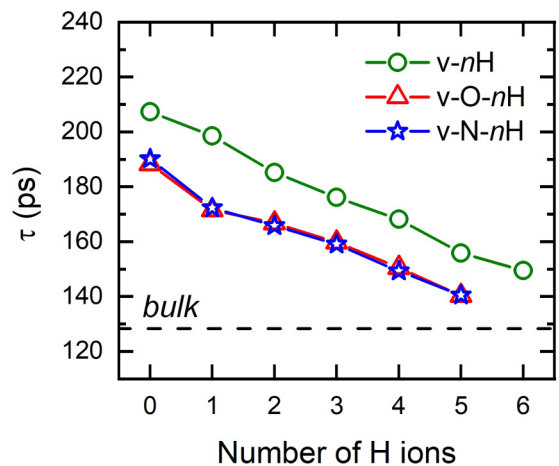


FIG. 14. Calculated lifetimes of positrons trapped at v - n H, v -N- n H and v -O- n H complexes as a function of the number n of hydrogen atoms attached to a vacancy. The bulk positron lifetime for Nb is indicated by dashed line.

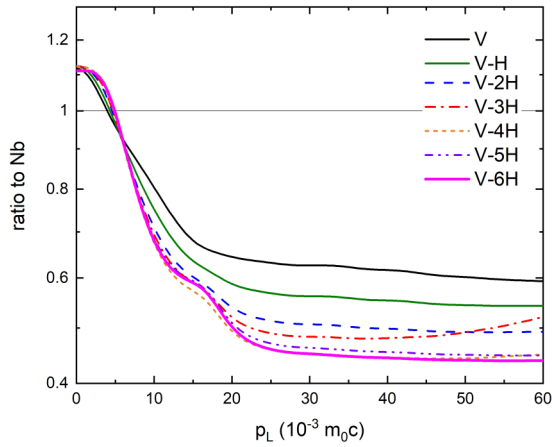


FIG. 15. Calculated momentum distributions for positrons trapped in v - n H complexes presented as ratio curves with respect to pure Nb.

The equilibrium geometry of a complex of a vacancy associated with a nitrogen atom (v -N) is shown in Fig. 17. Similarly to hydrogen at a vacancy, nitrogen is also located on the line connecting a vacancy and the nearest neighbor octahedral site. The displacement of the nitrogen from the octahedral site towards the vacancy is 0.09 \AA , i.e., smaller than that for hydrogen. The binding energy of nitrogen to a vacancy was calculated as

$$E_{B,v-N} = E[N - 1, v-N] + E[N, \text{bulk}] - (E[N - 1, v] + E[N, N_i]), \quad (\text{C9})$$

where $E[N - 1, v-N]$ is the energy of a supercell containing a v -N complex. This binding energy $E_{B,v-N} = -0.37 \text{ eV}$ is less negative compared to that for hydrogen indicating that nitrogen binding to vacancy is weaker than for hydrogen. Nevertheless, similarly to hydrogen, nitrogen absorbed in the Nb lattice facilitates the formation of vacancies and reduces the vacancy formation energy to $2.79 - 0.37 = 2.42 \text{ eV}$. The calculated positron density in the (001) plane containing a v -N

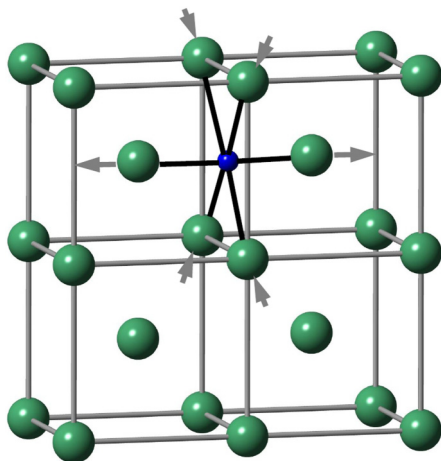


FIG. 16. Relaxed configuration of a nitrogen interstitial located in the octahedral interstitial site. Arrows show the directions of ion relaxations.

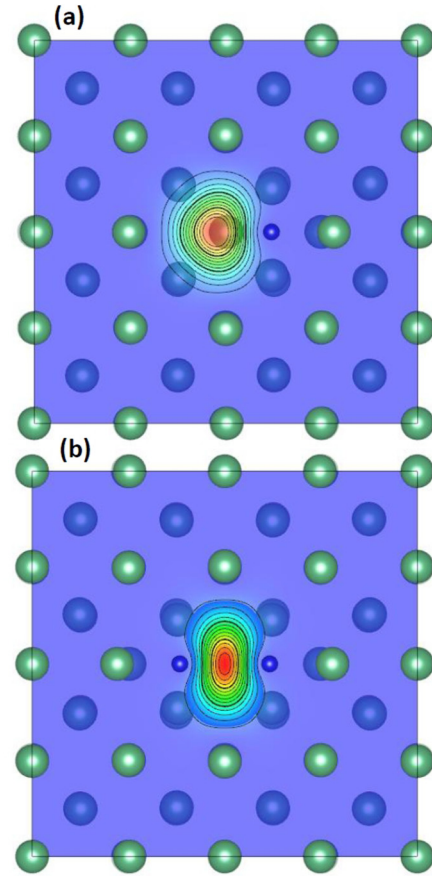


FIG. 17. Relaxed geometry of lattice ions and the positron density in the (001) plane for (a) a v -N complex, (b) a v -2N complex.

complex is plotted in Fig. 17(a). A positron is confined in a v -N complex, however, the asymmetry of the positron density due to a repulsion between the positron and the nitrogen is more pronounced compared to a v -H complex. Also the shortening of the positron lifetime compared to a bare vacancy is more pronounced and the calculated lifetime of positrons trapped in a v -N complex is 190 ps . Trapping of multiple nitrogen atoms in a vacancy has also been considered. The binding energy of an additional nitrogen atom to a vacancy associated already with n nitrogen atoms is given by the expression

$$E_{B,v-(n+1)N} = E[N - 1, v-(n+1)N] + E[N, \text{bulk}] - (E[N - 1, v-nN] + E[N, N_i]), \quad (\text{C10})$$

where $E[N - 1, v-(n+1)N]$ and $E[N - 1, v-nN]$ represent the energy of a supercell containing $v-(n+1)N$ and $v-nN$ complexes, respectively. The calculated binding energy is plotted in Fig. 18 as a function of the number of nitrogen atoms bound to a vacancy. From an inspection of the figure it is clear that the binding energy is only negative for $n \leq 2$. Hence, vacancies in Nb are able to trap up to two nitrogen atoms. v - n N complexes containing more than two nitrogen atoms are unstable. The calculated positron density in the (001) plane with a v -2N complex is shown in Fig. 17(b). Despite a reduction of the open volume, a v -2N complex is still able to trap

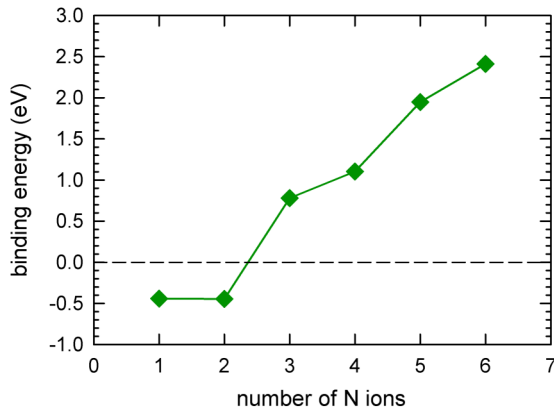


FIG. 18. Calculated binding energies of nitrogen atoms to a vacancy forming v - n N complexes.

positrons. However, the lifetime of positrons trapped in v -2N complexes is only 155 ps, i.e., it is significantly shortened compared to v -N.

The calculated momentum distributions of annihilating electron-positron pairs (ratio curves with respect to pure Nb) for stable v - n N complexes are plotted in Fig. 19. The presence of nitrogen bound to a vacancy leads to a peak located at momentum $p_L \approx 20 \times 10^{-3} m_0c$ due to the contribution of positrons annihilated by nitrogen p electrons. For v -2N complexes, the peak at $p_L \approx 20 \times 10^{-3} m_0c$ becomes more pronounced due to an increasing contribution of positrons annihilated in the vicinity of nitrogen.

4. Oxygen in Nb

Similarly to nitrogen, also oxygen absorbed in the Nb lattice is located in the octahedral interstitial site. The relaxation of Nb ions surrounding an oxygen interstitial (O_i) is similar to the case of N_i ; see Fig. 16. The two nearest neighbors of O_i relax outward (displacement 0.40 Å) while the four next nearest neighbors are displaced toward O_i (displacement -0.06 Å). The formation energy of (O_i) of -4.15 eV was calculated using Eq. (C8), only replacing nitrogen by oxygen.

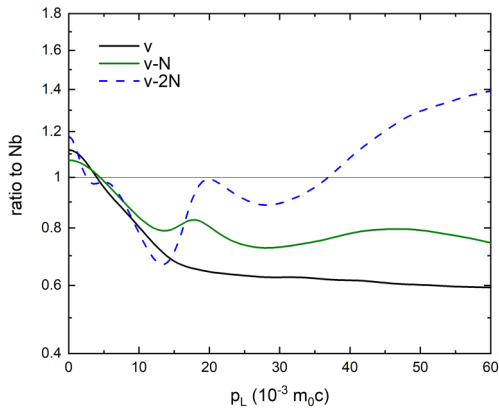


FIG. 19. Calculated momentum distributions for positrons trapped in a bare vacancy (v) and stable complexes of vacancy associated with nitrogen (v -N, v -2N). Momentum distributions are presented as ratio curves with respect to pure Nb.

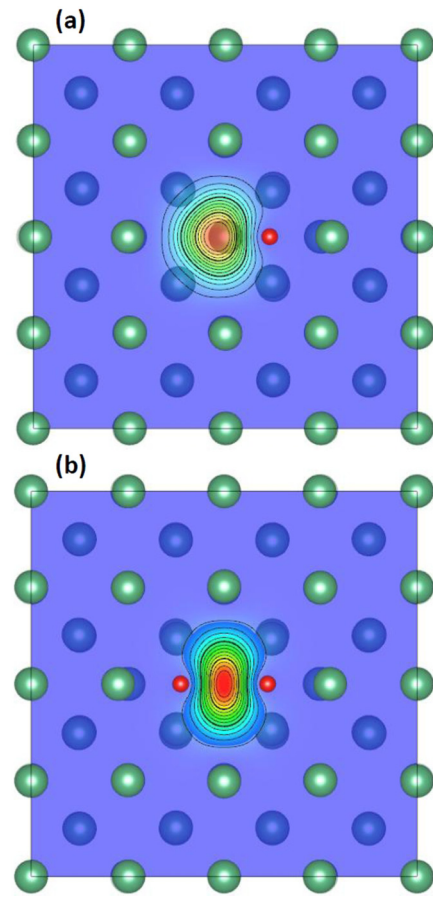


FIG. 20. Relaxed geometry of lattice ions and the positron density in the (001) plane for (a) a v -O complex, (b) a v -2O complex.

Hence, similarly to hydrogen and nitrogen, also the absorption of oxygen in the Nb lattice is an exothermic process. There is an attractive interaction between O_i and vacancies. The lowest energy configuration of a vacancy associated with oxygen (v -O) is similar to a v -N complex, i.e., the oxygen is located on the line between the vacancy and the nearest neighbor octahedral site. The oxygen is displaced 0.13 Å from the octahedral interstitial site towards the vacancy, and hence the distance of the oxygen from the vacancy is 1.53 Å. The binding energy of oxygen to a vacancy can be calculated using Eq. (C9) only replacing nitrogen by oxygen. The calculated binding energy of -0.83 eV indicates that oxygen is bound to a vacancy significantly stronger than nitrogen. In the presence of absorbed oxygen in the Nb lattice, the vacancy formation energy is reduced to $2.79 - 0.83 = 1.96$ eV. The calculated positron density in the (001) plane containing a v -O complex is plotted in Fig. 20(a). Similarly to v -N, a positron can also be localized in the v -O complex and the lifetime of positrons trapped in v -O was further shortened down to 188 ps.

Trapping of multiple oxygen atoms to a vacancy has been examined. The binding energy of an additional oxygen atom to a vacancy associated already with n oxygen atoms resulting in the transformation of a v - n O to a v - $(n + 1)$ O complex was calculated using Eq. (C10), only replacing nitrogen by oxygen, and is plotted in Fig. 21 as a function of number of

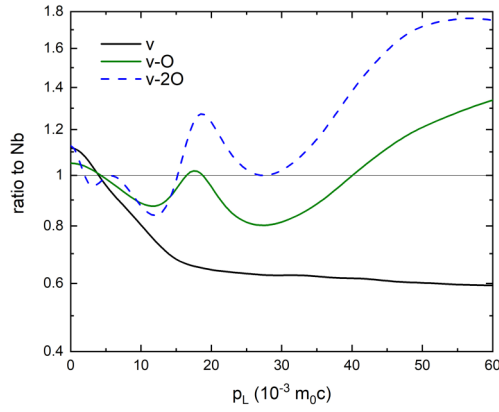


FIG. 21. Calculated binding energies of oxygen atoms to a vacancy forming v - n O complexes.

oxygen atoms trapped at a vacancy. Similarly to the case of nitrogen, vacancies are able to trap up to two oxygen atoms. For higher number of oxygen atoms, the v - n O complex becomes unstable.

The positron density in the (001) plane containing a v -2O complex shown in Fig. 20 is very similar to that for v -2N. The calculated lifetime of positrons trapped in v -2O is 166 ps, which is longer than the lifetime for v -2N complexes due to a smaller inward relaxation of Nb ions surrounding the v -2O complex.

The calculated momentum distributions of annihilating electron-positron pairs (ratio curves with respect to pure Nb) for stable v - n O complexes (v -O, v -2O) are plotted in Fig. 22. Similarly to the case of nitrogen, also the presence of oxygen bound to a vacancy is reflected by a peak at momentum $p_L \approx 20 \times 10^{-3} m_0c$ due to contributions of positrons annihilated by oxygen p electrons. Since oxygen contains one more p electron, the peak for a v -O complex is more pronounced than for a v -N complex. For the v -2O complex the peak further increases due to increasing contribution of positrons annihilated in the vicinity of oxygen atoms.

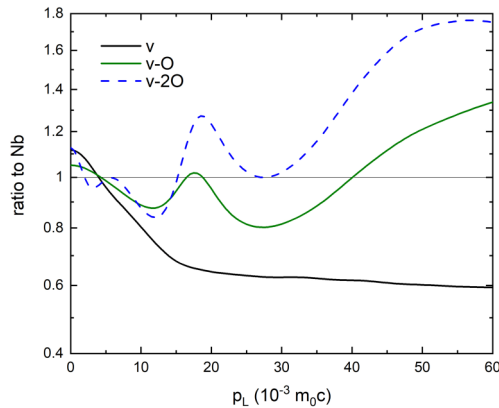


FIG. 22. Calculated momentum distributions for positrons trapped in a bare vacancy (v) and stable complexes of vacancy associated with oxygen (v -O, v -2O). Momentum distributions are presented as ratio curves with respect to pure Nb.

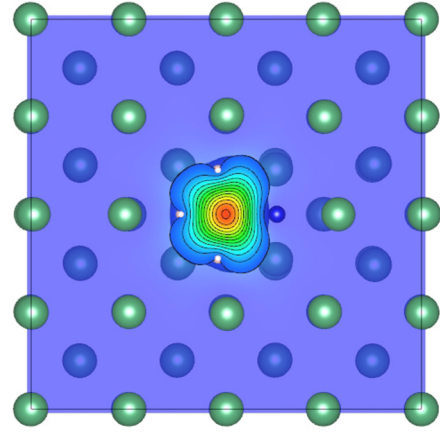


FIG. 23. Relaxed ion positions and the positron density in the (001) plane containing a v -N-5H complex.

5. H trapping in v -N and v -O complexes

It is interesting to examine the possibility of hydrogen trapping in vacancies containing already trapped O or N atoms leading to the formation of v -N- n H or v -O- n H complexes. It was found that in the lowest energy configuration of such complexes, hydrogen atoms are now located close to the octahedral interstitial sites around a vacancy which are not occupied by an oxygen or nitrogen interstitial. As an example, Fig. 23 shows the equilibrium configuration of v -N-5H complex. The binding energy of a hydrogen atom to a vacancy associated already with a nitrogen atom and n hydrogen atoms leading to a transformation of a v -N- n H complex to a v -N- $(n+1)$ H complex can be calculated from the expression

$$\begin{aligned}
 E_{B,v-N-(n+1)N} &= E[N-1, v-N-(n+1)H] \\
 &+ E[N, \text{bulk}] + ZPE[v-N-(n+1)H] \\
 &- (E[N-1, v-N-nH] + E[N, H_i]) \\
 &+ ZPE[v-N-nH] + ZPE[H_i],
 \end{aligned}$$

where $E[N-1, v-N-(n+1)H]$ and $E[N-1, v-N-nH]$ denote the energy of a supercell containing v -N- $(n+1)H$ and v -N- nH complexes, respectively. The binding energy of an additional hydrogen atom to a v -O- nH complex can be calculated using the same equation only replacing nitrogen by oxygen. The calculated binding energies are plotted in Fig. 12 as a function of the number of hydrogen atoms. From an inspection of the figure one can conclude that both v -N and v -O complexes are able to trap up to five hydrogen atoms. The strength of the hydrogen bond to a v -N and v -O complex is comparable but weaker than for a bare vacancy. The absolute values of the binding energy of additional hydrogen atoms decreases with an increasing number of hydrogen atoms associated with v -N or v -O complexes, indicating that binding of additional hydrogen atoms to the complex becomes weaker and weaker. The lifetimes of positrons trapped in v -N- nH and v -O- nH complexes are plotted in Fig. 14 as a function of the number n of hydrogen atoms. Positron lifetimes for v -N- nH and v -O- nH complexes are very similar and monotonically decreases towards the bulk lifetime with increasing number of H atoms.

- [1] M. Venkatesan, C. B. Fitzgerald, and J. M. D. Coey, Unexpected magnetism in a dielectric oxide, *Nature (London)* **430**, 630 (2004).
- [2] N. H. Hong, J. Sakai, N. Poirot, and V. Brize, Room-temperature ferromagnetism observed in undoped semiconducting and insulating oxide thin films, *Phys. Rev. B* **73**, 132404 (2006).
- [3] M. Weissmann and L. A. Errico, The role of vacancies, impurities and crystal structure in the magnetic properties of TiO_2 , *Phys. B: Condens. Matter* **398**, 179 (2007).
- [4] R. C. Dynes, V. Narayanamurti, and J. P. Garno, Direct Measurement of Quasiparticle-Lifetime Broadening in a Strongly-Coupled Superconductor, *Phys. Rev. Lett.* **41**, 1509 (1978).
- [5] T. Proslir, J. F. Zasadzinski, L. Cooley, C. Antoine, J. Moore, J. Norem, M. Pellin, and K. E. Gray, Tunneling study of cavity grade Nb: Possible magnetic scattering at the surface, *Appl. Phys. Lett.* **92**, 212505 (2008).
- [6] T. Proslir, M. Kharitonov, M. Pellin, J. Zasadzinski, and G. Ciovati, Evidence of surface paramagnetism in niobium and consequences for the superconducting cavity surface impedance, *IEEE Trans. Appl. Supercond.* **21**, 2619 (2011).
- [7] M. Konczykowski, T. Proslir, A. Glatz, and M. J. Pellin, Surface impedance of superconductors with magnetic impurities, *Phys. Rev. B* **86**, 024515 (2012).
- [8] N. R. Groll, C. Becker, G. Ciovati, A. Grassellino, A. Romanenko, J. F. Zasadzinski, and T. Proslir, Insight into bulk niobium superconducting RF cavities performances by tunneling spectroscopy, [arXiv:1805.06359](https://arxiv.org/abs/1805.06359).
- [9] T. Kubo and A. Gurevich, Field-dependent nonlinear surface resistance and its optimization by surface nanostructuring in superconductors, *Phys. Rev. B* **100**, 064522 (2019).
- [10] J. Koch, T. M. Yu, J. Gambetta, A. A. Houck, D. I. Schuster, J. Majer, A. Blais, M. H. Devoret, S. M. Girvin, and R. J. Schoelkopf, Charge-insensitive qubit design derived from the Cooper pair box, *Phys. Rev. A* **76**, 042319 (2007).
- [11] J. A. Schreier, A. A. Houck, J. Koch, D. I. Schuster, B. R. Johnson, J. M. Chow, J. M. Gambetta, J. Majer, L. Frunzio, M. H. Devoret, S. M. Girvin, and R. J. Schoelkopf, Suppressing charge noise decoherence in superconducting charge qubits, *Phys. Rev. B* **77**, 180502 (2008).
- [12] A. A. Murthy, P. M. Das, S. M. Ribet, C. Kopas, J. Lee, M. J. Reagor, L. Zhou, M. J. Kramer, M. C. Hersam, M. Checchin, A. Grassellino, R. dos Reis, V. P. Dravid, and A. Romanenko, Insights into improving performance of niobium superconducting transmon qubit devices through advanced microscopy, [arXiv:2203.08710](https://arxiv.org/abs/2203.08710).
- [13] A. A. Murthy, P. M. Das, S. M. Ribet, C. Kopas, J. Lee, M. J. Reagor, L. Zhou, M. J. Kramer, M. C. Hersam, M. Checchin, A. Grassellino, R. dos Reis, V. P. Dravid, and A. Romanenko, Potential nanoscale sources of decoherence in niobium based transmon qubit architectures, [arXiv:2203.08710](https://arxiv.org/abs/2203.08710).
- [14] D. A. Bennett, L. Longobardi, V. Patel, W. Chen, D. V. Averin, and J. E. Lukens, Decoherence in RF SQUID qubits, *Quantum Inf. Process.* **8**, 217 (2009).
- [15] G. Wendin, Quantum information processing with superconducting circuits: a review, *Rep. Prog. Phys.* **80**, 106001 (2017).
- [16] C. Müller, J. H. Cole, and J. Lisenfeld, Towards understanding two-level-systems in amorphous solids: insights from quantum circuits, *Rep. Prog. Phys.* **82**, 124501 (2019).
- [17] D. Lee, J. L. DuBois, and V. Lordi, Identification of the Local Sources of Paramagnetic Noise in Superconducting Qubit Devices Fabricated on Al_2O_3 Substrates Using Density-Functional Calculations, *Phys. Rev. Lett.* **112**, 017001 (2014).
- [18] N. Adelstein, D. Lee, J. L. DuBois, K. G. Ray, J. B. Varley, and V. Lordi, Magnetic stability of oxygen defects on the SiO_2 surface, *AIP Adv.* **7**, 025110 (2017).
- [19] R. de Sousa, Dangling-bond spin relaxation and magnetic $1/f$ noise from the amorphous-semiconductor/oxide interface: Theory, *Phys. Rev. B* **76**, 245306 (2007).
- [20] A. Romanenko and D. I. Schuster, Understanding Quality Factor Degradation in Superconducting Niobium Cavities at Low Microwave Field Amplitudes, *Phys. Rev. Lett.* **119**, 264801 (2017).
- [21] A. Romanenko, R. Pilipenko, S. Zorzetti, D. Frolov, M. Awida, S. Belomestnykh, S. Posen, and A. Grassellino, Three-Dimensional Superconducting Resonators at $T < 20$ mK with Photon Lifetimes up to $\tau = 2$ s, *Phys. Rev. Appl.* **13**, 034032 (2020).
- [22] S. Posen, A. Romanenko, A. Grassellino, O. S. Melnychuk, D. A. Sergatskov *et al.*, Ultralow Surface Resistance via Vacuum Heat Treatment of Superconducting Radio-Frequency Cavities, *Phys. Rev. Appl.* **13**, 014024 (2020).
- [23] J. T. Maniscalco, M. Ge, D. Gonnella, and M. Liepe, Investigation of the Origin of the Anti-Q-Slope, in *North American Particle Accelerator Conference 2016*, Chicago, October 2016, edited by M. Power, V. Shiltsev, V. R. W. Schaa, and M. White (JACoW, Geneva, 2016).
- [24] M. Martinello, M. Checchin, A. Romanenko, A. Grassellino, S. Aderhold, S. K. Chandrasekeran, O. Melnychuk, S. Posen, and D. A. Sergatskov, Field-Enhanced Superconductivity in High-Frequency Niobium Accelerating Cavities, *Phys. Rev. Lett.* **121**, 224801 (2018).
- [25] B. P. Xiao, C. E. Reece, and M. J. Kelley, Superconducting surface impedance under radiofrequency field, *Physica C* **490**, 26 (2013).
- [26] A. Gurevich, Reduction of Dissipative Nonlinear Conductivity of Superconductors by Static and Microwave Magnetic Fields, *Phys. Rev. Lett.* **113**, 087001 (2014).
- [27] R. Ballantini, A. Dacca, G. Gemme, and R. Parodi, Improvement of the Maximum Field of Accelerating Cavities by Dry Oxidation, in *Proceedings of the 9th International Conference on RF Superconductivity, Santa Fe, November 1999* (JACoW, Geneva, 1999).
- [28] T. Kubo, Effects of Nonmagnetic Impurities and Subgap States on the Kinetic Inductance, Complex Conductivity, Quality Factor and Depairing Current Density, *Phys. Rev. Appl.* **17**, 014018 (2022).
- [29] F. Herman, and R. Hlubina, Microscopic interpretation of the Dynes formula for the tunneling density of states, *Phys. Rev. B* **94**, 144508 (2016).
- [30] F. Herman and R. Hlubina, Microwave response of superconductors that obey local electrodynamics, *Phys. Rev. B* **104**, 094519 (2021).
- [31] F. He, W. Pan, P. Sha, J. Zhai, Z. Mi, X. Dai, S. Jin, Z. Zhang, C. Dong, B. Liu, H. Zhao, R. Ge, J. Zhao, Z. Mu, L. Du, L. Sun, L. Zhang, C. Yang, and X. Zheng, Medium-temperature baking of 1.3 GHz superconducting radio frequency single-cell cavity, *Supercond. Sci. Technol.* **34**, 095005 (2021).

- [32] H. Ito, H. Araki, K. Takahashi, and K. Umemori, Influence of furnace baking on QE behavior of superconducting accelerating cavities, *Prog. Theor. Exp. Phys.* **2021**, 071G01 (2021).
- [33] J. Čížek, Characterization of lattice defects in metallic materials by positron annihilation spectroscopy: A review, *J. Mater. Sci Technol.* **34**, 577 (2018).
- [34] G. D. L. Semione, A. Dangwal Pandey, S. Tober, J. Pfrommer, A. Poulain, J. Drnec, G. Schütz, T. F. Keller, H. Noei, V. Vonk, B. Foster and A. Stierle, Niobium near-surface composition during nitrogen infusion relevant for superconducting radio-frequency cavities, *Phys. Rev. Accel. Beams* **22**, 103102 (2019).
- [35] L. G. Parratt, Surface Studies of Solids by Total Reflection of X-Rays, *Phys. Rev.* **95**, 359 (1954).
- [36] A. Stierle, FEWLA: A software for fitting X-ray reflectivity curves. andreas.stierle@desy.de
- [37] R. Krause-Rehberg, and H. S. Leipner, *Positron Annihilation in Semiconductors: Defect Studies* (Springer-Verlag, Berlin, 1999).
- [38] J. Čížek, I. Prochazka, S. Danis, G. Brauer, W. Anwand, R. Gemma, E. Nikitin, R. Kirchheim, A. Pundt, and R. K. Islamgaliev, Hydrogen-vacancy complexes in electron-irradiated niobium, *Phys. Rev. B* **79**, 054108 (2009).
- [39] W. Anwand, G. Brauer, M. Butterling, H. R. Kissener, and A. Wagner, Design and construction of a slow positron beam for solid and surface investigations, *Defect. Diffus. Forum* **331**, 25 (2012).
- [40] M. O. Liedke, W. Anwand, R. Bali, S. Cornelius, M. Butterling, T. T. Trinh, A. Wagner, S. Salamon, D. Walecki, A. Smekhova, H. Wende, and K. Potzger, Open volume defects and magnetic phase transition in Fe₆₀Al₄₀ transition metal aluminide, *J. Appl. Phys.* **117**, 163908 (2015).
- [41] A. Wagner, M. Butterling, M. O. Liedke, K. Potzger, and R. Krause-Rehberg, Positron annihilation lifetime and Doppler broadening spectroscopy at the ELBE facility, in International Workshop on Physics with Positrons at Jefferson Lab, 12–15 September 2017, Newport News, VA, *AIP Conf. Proc. No. 1970* (AIP, New York, 2018), p. 40003.
- [42] PALSfit3, Version 3.218, <http://palsfit.dk/>
- [43] Origin(Pro), Version 2019b, OriginLab Corporation, Northampton, MA, USA.
- [44] G. Kresse and J. Hafner, *Ab initio* molecular dynamics for liquid metals, *Phys. Rev. B* **47**, 558 (1993).
- [45] G. Kresse and J. Furthmüller, Efficient iterative schemes for *ab initio* total-energy calculations using a plane-wave basis set, *Phys. Rev. B* **54**, 11169 (1996).
- [46] J. P. Perdew and A. Zunger, Self-interaction correction to density-functional approximations for many-electron systems, *Phys. Rev. B* **23**, 5048 (1981).
- [47] J. P. Pedrew, *Electronic Structure of Solids*, 1991 edition, edited by P. Ziesche and H. Eschrig (Akademie Verlag, Berlin, 1991), Vol. 11.
- [48] H. J. Monkhorst and J. D. Pack, Special points for Brillouin-zone integrations, *Phys. Rev. B* **13**, 5188 (1976).
- [49] M. J. Puska and R. M. Nieminen, Theory of positrons in solids and on solid-surfaces, *Rev. Mod. Phys.* **66**, 841 (1994).
- [50] M. Alatalo, B. Barbiellini, M. Hakala, H. Kauppinen, T. Korhonen, M. J. Puska, K. Saarinen, P. Hautiojärvi, and R. M. Nieminen, Theoretical and experimental study of positron annihilation with core electrons in solids, *Phys. Rev. B* **54**, 2397 (1996).
- [51] J. Kuriplach, A. L. Morales, C. Dauwe, D. Segers, and M. Sob, Vacancies and vacancy-oxygen complexes in silicon: Positron annihilation with core electrons, *Phys. Rev. B* **58**, 10475 (1998).
- [52] S. Aderhold, S. Chel, E. Elsen, F. Eozénou, L. Lilje, and D. Reschke, Cavity Process, ILC HiGrade Report, 2015 (unpublished).
- [53] D. Reschke, V. Gubarev, J. Schaffran, L. Steder, N. Walker, M. Wenskat, and L. Monaco, Performance in the vertical test of the 832 nine-cell 1.3 GHz cavities for the European X-ray Free Electron Laser, *Phys. Rev. Accel. Beams* **20**, 042004 (2017).
- [54] DESY XFEL Project Group and European XFEL Project Team, *The Technical Design Report of the European XFEL*, edited by M. Altarelli, R. Brinkmann, M. Chergui, W. Decking, B. Dobson, S. Düsterer, G. Grübel, W. Graeff, H. Graafsma, J. Hajdu, J. Marangos, J. Pflüger, H. Redlin, D. Riley, I. Robinson, J. Rossbach, A. Schwarz, K. Tiedtke, T. Tschentscher, I. Vartaniants, H. Wabnitz, H. Weise, R. Wichmann, K. Witte, A. Wolf, M. Wulff, and M. Yurkov (Deutsches Elektronen-Synchrotron, Hamburg, 2007).
- [55] W. Singer, X. Singer, A. Brinkmann, J. Iversen, A. Matheisen, A. Navitski, Y. Tamashevich, P. Michelato, and L. Monaco, Production of superconducting 1.3-GHz cavities for the European X-ray Free Electron Laser, *Phys. Rev. Accel. Beams* **19**, 092001 (2016).
- [56] H. Padamsee, J. Knobloch, and T. Hays, *RF Superconductivity for Accelerators*, 2nd ed. (Wiley-VCH, Weinheim, 2008).
- [57] M. Wenskat, J. Cizek, M. O. Liedke, M. Butterling, C. Bate, P. Hausild, E. Hirschmann, A. Wagner, and H. Weise, Vacancy-hydrogen interaction in niobium during low-temperature baking, *Sci. Rep.* **10**, 8300 (2020).
- [58] M. Delheusy, X-ray investigation of Nb/O interfaces, Ph.D. thesis, Universität Stuttgart, 2008.
- [59] E. M. Lechner, J. W. Angle, F. A. Stevie, M. J. Kelley, C. E. Reece, and A. D. Palczewski, RF surface resistance tuning of superconducting niobium via thermal diffusion of native oxide, *Appl. Phys. Lett.* **119**, 082601 (2021).
- [60] M. W. Stanley and Z. C. Szkopiak, The α and β peaks in cold-worked niobium, *J. Mater. Sci.* **2**, 559 (1967).
- [61] P. G. De Gennes and J. P. Hurault, Proximity effects under magnetic fields. II - Interpretation of breakdown, *Phys. Lett.* **17**, 181 (1965).
- [62] A. Romanenko, F. Barkov, L. D. Cooley, and A. Grassellino, Proximity breakdown of hydrides in superconducting niobium cavities, *Supercond. Sci. Technol.* **26**, 035003 (2013).
- [63] Z. Nishiyama, X-ray investigation of the mechanism of the transformation from face-centered cubic lattice to body-centered cubic lattice, *Sci. Rep. Tohoku Univ.* **23**, 638 (1934).
- [64] G. Wassermann, Influence of the α - γ transformation of an irreversible Ni steel onto crystal orientation and tensile strength, *Arch. Eisenhüttenwes.* **126**, 647 (1933).
- [65] Y. Gotoh and M. Uwaha, Geometrical interpretation of the interfacial energy between bcc and fcc lattices and preferred orientation relationship of the epitaxy, *Jpn. J. Appl. Phys.* **26**, L17 (1987).
- [66] H. Boschker, E. Fillis-Tsirakis, C. Richter, D. Zhang, J. Smet, and L. Kuerten, Microscopic origin of the Dynes parameter Γ of the LaAlO₃/SrTiO₃ interface superconductor, *Phys. Rev. B* **102**, 134506 (2020).
- [67] M. Wenskat, Vacancy-Hydrogen Dynamics and Magnetic Impurities During Mid-T Bake, in *Proceedings of the 20th*

- International Conference on RF Superconductivity*, East Lansing, MI, June-July 2021, edited by K. Saito, T. Xu, N. Sakamoto, Y. Lesage, and V. R. W. Schaa (JACoW, Geneva, 2021).
- [68] Q. Ma, P. Ryan, J. W. Freeland, and R. A. Rosenberg, Thermal effect on the oxides on Nb (100) studied by synchrotron-radiation x-ray photoelectron spectroscopy, *J. Appl. Phys.* **96**, 7675 (2004).
- [69] K. Zhussupbekov, K. Walshe, S. I. Bozhko, A. Ionov, K. Fleischer, E. Norton, A. Zhussupbekova, V. Semenov, I. V. Shvets, and B. Walls, Oxidation of Nb (110): atomic structure of the NbO layer and its influence on further oxidation, *Sci. Rep.* **10**, 3794 (2020).
- [70] E. Sheridan, T. F. Harrelson, E. Sivonxay, K. A. Persson, M. V. P. Altoé, I. Siddiqi, D. F. Ogletree, D. I. Santiago, and S. M. Griffin, Microscopic theory of magnetic disorder-induced decoherence in superconducting Nb films, [arXiv:2111.11684](https://arxiv.org/abs/2111.11684).
- [71] T. F. Harrelson, E. Sheridan, E. Kennedy, J. Vinson, A. T. N'Diaye, M. Virginia, P. Altoe, A. Schwartzberg, I. Siddiqi, D. F. Ogletree, M. C. Scott, and S. M. Griffin, Elucidating the local atomic and electronic structure of amorphous oxidized superconducting niobium films, *Appl. Phys. Lett.* **119**, 244004 (2021).
- [72] H. Shiba, A Hartree-Fock theory of transition-metal impurities in a superconductor, *Prog. Theor. Phys.* **50**, 50 (1973).
- [73] D. C. Ford, L. D. Cooley, and D. N. Seidman, Suppression of hydride precipitates in niobium superconducting radio-frequency cavities, *Supercond. Sci. Technol.* **26**, 105003 (2013).
- [74] P. Schiller and A. Schneiders, On the hydrogen relaxation peak in niobium, *Phys. Status Solidi A* **29**, 375 (1975).
- [75] K. Saarinen, P. Hautajarvi, and C. Corbel, Positron Annihilation Spectroscopy of Defects in *Semiconductors*, in *Identification of Defects in Semiconductors*, edited by M. Stavola (Elsevier, Amsterdam, 1998), Chap. 5.
- [76] J. Dryzek and P. Horodek, GEANT4 simulation of slow positron beam implantation profiles, *Nucl. Instrum. Methods Phys. Res., Sect. B* **266**, 4000 (2008).
- [77] O. E. Mogensen, Positronium formation in condensed matter and high-density gases, in *Proceedings of the 6th International Conference on Positron Annihilation*, Arlington, April 1982, edited by P. G. Coleman, S. C. Sharma, and L. M. Diana (North-Holland, Amsterdam, 1982).
- [78] M. Charlton and J. W. Humberston, *Positron Physics* (Cambridge University Press, Cambridge, 2001).
- [79] C. H. Hodges and M. J. Stott, Work functions for positrons in metals, *Phys. Rev. B* **7**, 73 (1973).
- [80] S. J. Tao, Positronium annihilation in molecular substances, *J. Chem. Phys.* **56**, 5499 (1972).
- [81] M. Eldrup, D. Lightbody, and J. N. Sherwood, The temperature-dependence of positron lifetimes in solid pivalic acid, *Chem. Phys.* **63**, 51 (1981).
- [82] M. Deutsch and E. Dulit, Short range interaction of electrons and fine structure of positronium, *Phys. Rev.* **84**, 601 (1951).
- [83] M. Deutsch and S. C. Brown, Zeeman effect and hyperfine splitting of positronium, *Phys. Rev.* **85**, 1047 (1952).
- [84] O. Halpern, Magnetic quenching of the positronium decay, *Phys. Rev.* **94**, 904 (1954).
- [85] P. Moskal, D. Kisielewska, C. Curceanu, E. Czerwinski, K. Dulski, A. Gajos, M. Gorgol, B. Hiesmayr, B. Jasinska, and K. Kacprzak, Feasibility study of the positronium imaging with the J-PET tomograph, *Phys. Med. Biol.* **64**, 055017 (2019).
- [86] E. Boroński and R. M. Nieminen, Electron-positron density-functional theory, *Phys. Rev. B* **34**, 3820 (1986).
- [87] T. Korhonen, M. J. Puska, and R. M. Nieminen, First-principles calculation of positron annihilation characteristics at metal vacancies, *Phys. Rev. B* **54**, 15016 (1996).
- [88] D. C. Ford, P. Zapol, and L. D. Cooley, First-principles study of carbon and vacancy structures in niobium, *J. Phys. Chem. C* **119**, 14728 (2015).
- [89] W. Frank, U. Breier, C. Elsässer, and M. Fährhne, Properties of monovacancies and self-interstitials in bcc Li: An *ab initio* pseudopotential study, *Phys. Rev. B* **48**, 7676 (1993).
- [90] T. Beuerle, R. Pawellek, C. Elsässer, and M. Fährhne, The influence of the atomic-sphere approximation on the calculation of the vacancy formation energy of Li, *J. Phys.: Condens. Matter* **3**, 1957 (1991).
- [91] P. Hautajarvi, H. Huomo, M. J. Puska, and A. Vehanen, Vacancy recovery and vacancy-hydrogen interaction in niobium and tantalum studied by positrons, *Phys. Rev. B* **32**, 4326 (1985).
- [92] D. C. Ford, L. D. Cooley, and D. N. Seidman, First-principles calculations of niobium hydride formation in superconducting radio-frequency cavities, *Supercond. Sci. Technol.* **26**, 095002 (2013).
- [93] J. A. Pryde and C. G. Titcomb, Thermodynamic data of the hydrogen-niobium system, *J. Phys. C: Solid State Phys.* **5**, 1301 (1972).
- [94] J. Čížek, I. Procházka, F. Bečvář, R. Kužel, M. Cieslar, G. Brauer, W. Anwand, R. Kirchheim, and Astrid Pundt, Hydrogen-induced defects in bulk niobium, *Phys. Rev. B* **69**, 224106 (2004).
- [95] A. Pundt and R. Kirchheim, Hydrogen in metals: microstructural aspects, *Annu. Rev. Mater. Res.* **36**, 555 (2006).
- [96] Y. Tateyama and T. Ohno, Stability and clusterization of hydrogen-vacancy complexes in α -Fe: An *ab initio* study, *Phys. Rev. B* **67**, 174105 (2003).
- [97] K. Ohsawa, J. Goto, M. Yamakami, M. Yamaguchi, and M. Yagi, Trapping of multiple hydrogen atoms in a tungsten monovacancy from first principles, *Phys. Rev. B* **82**, 184117 (2010).